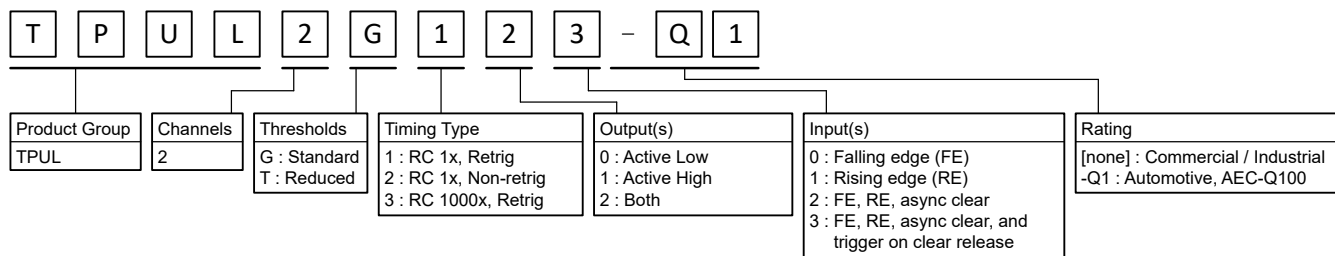# TPUL2T323 Dual Retriggerable Extended RC-Timed Monostable Multivibrators

1 Features

- RC configurable from 10ms to 880s
- Extended pulse width functionality reduces capacitor value required for long pulse widths by factor of 1000
- For pulses less than 10ms, use TPUL2G123
- 1% typical, 10% maximum pulse width variation
- Wide operating range of 1.5V to 5.5V
- Inputs accept voltages up to 5.5V
- TTL-compatible with 4.5V to 5.5V supply
- Schmitt-trigger architecture on all inputs
- Single-supply voltage translator (refer to *Reduced Input Threshold Voltage*):
    - Up translation:
        - 1.2V to 1.8V
        - 1.5V to 2.5V
        - 1.8V to 3.3V
        - 3.3V to 5.0V
    - Down translation:
        - 5.0V, 3.3V, 2.5V to 1.8V
        - 5.0V, 3.3V to 2.5V
        - 5.0V to 3.3V

2 Applications

- Demodulate a digital Amplitude Shift Keying (ASK) signal
- Reset a system for a fixed period of time
- Generate a positive fixed-width digital pulse
- Detect a digital signal rising edge
- Detect a digital signal falling edge
- Debounce a switch

3 Description

The TPUL2T323 device contains two independent extended-pulse-width RC-configurable retriggerable monostable multivibrators designed for 1.5V to 5.5V operation. The output pulse duration is configured by selecting external resistance and capacitance values with an approximate output pulse width of $t_{wo} \cong 1000 \times R \times C$.

This device features three inputs, allowing for rising edge (T) and falling edge ($\overline{T}$) triggers and a clear input ($\overline{CLR}$) that can be used asynchronously to stop an active output pulse. All inputs include Schmitt-trigger architecture to allow for slow input transition rates and improve noise immunity.

Device Information

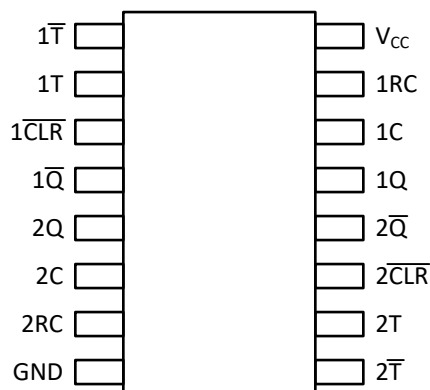| PART NUMBER	PACKAGE [1]	PACKAGE SIZE[2]	BODY SIZE
TPUL2T323	PW (TSSOP, 16)	5mm × 6.4mm	5mm × 4.4mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

(2) The package size (length × width) is a nominal value and includes pins, where applicable.

| T | P | U | L | 2 | G | 1 | 2 | 3 | – | Q | 1 |

Product Group	Channels	Thresholds	Timing Type	Output(s)	Input(s)	Rating
TPUL	2	G : Standard T : Reduced	1 : RC 1x, Retrig 2 : RC 1x, Non-retrig 3 : RC 1000x, Retrig	0 : Active Low 1 : Active High 2 : Both	0 : Falling edge (FE) 1 : Rising edge (RE) 2 : FE, RE, async clear 3 : FE, RE, async clear, and trigger on clear release	[none] : Commercial / Industrial -Q1 : Automotive, AEC-Q100

TPUL Family Naming Convention

ADVANCE INFORMATION

Table of Contents

ADVANCE INFORMATION

4 Pin Configuration and Functions

1$\overline{\text{T}}$			V$_{CC}$
1T			1RC
1$\overline{\text{CLR}}$			1C
1$\overline{\text{Q}}$			1Q
2Q			2$\overline{\text{Q}}$
2C			2$\overline{\text{CLR}}$
2RC			2T
GND			2$\overline{\text{T}}$

See mechanical drawings for dimensions.

Figure 4-1. PW Package 16-Pin TSSOP Top View

Table 4-1. Pin Functions

PIN NAME	PIN NO.	I/O[1]	DESCRIPTION
1$\overline{\text{T}}$	1	I	Channel 1 falling edge trigger input; requires 1T and 1$\overline{\text{CLR}}$ to be held high
1T	2	I	Channel 1 rising edge trigger input; requires 1$\overline{\text{T}}$ to be held low and 1$\overline{\text{CLR}}$ to be held high
1$\overline{\text{CLR}}$	3	I	Channel 1 asynchronous clear input, active low; also can operate as rising edge trigger input if 1$\overline{\text{T}}$ is held low and 1T is held high
1$\overline{\text{Q}}$	4	O	Channel 1 inverted output
2Q	5	O	Channel 2 output
2C	6	G	Channel 2 external timing capacitor negative connection; provides a return path for discharge current of the external timing capacitor; internally connected to ground
2RC	7	I/O	Channel 2 external timing node connection; see *Application Information* section for detailed operation instructions
GND	8	G	Ground
2$\overline{\text{T}}$	9	I	Channel 2 falling edge trigger input; requires 2T and 2$\overline{\text{CLR}}$ to be held high
2T	10	I	Channel 2 rising edge trigger input; requires 2$\overline{\text{T}}$ to be held low and 2$\overline{\text{CLR}}$ to be held high
2$\overline{\text{CLR}}$	11	I	Channel 2 asynchronous clear input, active low; also can operate as rising edge trigger input if 2$\overline{\text{T}}$ is held low and 2T is held high
2$\overline{\text{Q}}$	12	O	Channel 2 inverted output
1Q	13	O	Channel 1 output
1C	14	G	Channel 1 external timing capacitor negative connection; provides a return path for discharge current of the external timing capacitor; internally connected to ground
1RC	15	I/O	Channel 1 external timing node connection; see *Application Information* section for detailed operation instructions
V$_{CC}$	16	P	Postive voltage supply

(1)   I = Input, O = Output, I/O = Input and output, G = Ground, P = Power

ADVANCE INFORMATION

5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)[1]

				MIN	MAX	UNIT
V_{CC}	Supply voltage range			−0.5	6.5	V
V_I	Digital input voltage range[2]			−0.5	6.5	V
V_O	Digital output voltage range in the active state[2]			−0.5	V_{CC} + 0.5	V
V_O	Digital output voltage range in the high-impedance state[2]			−0.5	6.5	V
V_{RC}	RC pin voltage range			−0.5	V_{CC} + 0.5	V
I_{IK}	Input clamp diode current, continuous	V_I < -0.5V			−20	mA
	Input clamp diode current, pulsed 1μs	V_I < -0.5V			−200	mA
I_{OK}	Output clamp diode current, continuous	V_O < -0.5V			−20	mA
	Output clamp diode current, pulsed 1μs	V_O < -0.5V			−200	mA
I_O	Digital output current, continuous	V_O = 0 to V_{CC}			±50	mA
	Digital output current, pulsed 1μs	V_O = 0 to V_{CC}			±200	mA
	Continuous current through V_{CC} or GND				±200	mA
R_{ext}	External timing resistance			1		kΩ
C_{ext}	External timing capacitance				1[3]	μF
T_J	Junction temperature				150	°C
T_{stg}	Storage temperature			−65	150	°C

(1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. Absolute maximum ratings do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If briefly operating outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not sustain damage, but it may not be fully functional. Operating the device in this manner may affect device reliability, functionality, performance, and shorten the device lifetime.
(2) The voltage ratings may be exceeded if the associated clamp current ratings are observed.
(3) The timing capacitance maximum value can be exceeded if an external diode is added. See *Application and Implementation* section for details.

5.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001[1]	±2000	V
		Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002[2]	±1000	

(1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

Spec	Description	Condition	MIN	MAX	UNIT
V_{CC}	Supply voltage		1.5	5.5	V
V_I	Input Voltage[1]		0	5.5	V
V_O	Output Voltage		0	V_{CC}	V
I_{OH} [3]	High-level output current	V_{CC} = 1.5V		−4	mA
		V_{CC} = 1.8V		−6	mA
		V_{CC} = 2.5V		−26	mA
		V_{CC} = 3.3V		−50	mA
		V_{CC} = 5V		−50	mA

ADVANCE INFORMATION

over operating free-air temperature range (unless otherwise noted)

Spec	Description	Condition	MIN	MAX	UNIT
I_{OL} [3]	Low-level output current	V_{CC} = 1.5V		4	mA
		V_{CC} = 1.8V		6	mA
		V_{CC} = 2.5V		26	mA
		V_{CC} = 3.3V		50	mA
		V_{CC} = 5V		50	mA
R_{ext} [2]	External timing resistance	V_{CC} = 1.5V to 5.5V	6.5	1000	kΩ
C_{ext} [2]	External timing capacitance	V_{CC} = 1.5V to 5.5V	0.1	1000	nF
t_{wo}	Configured output pulse width	V_{CC} = 1.5V to 5.5V	0.01	880	s
C_L	Digital output load capacitance	V_{CC} = 1.5V to 5.5V		50	pF
V_{POR}	Power-on reset ramp voltage	$\Delta t/\Delta V_{CC}$ = 20µs/V to 100ms/V	0.3	1.5	V
$\Delta t/\Delta V_{CC}$	Power-on ramp rate	V_{CC} = 0.3V to 1.5V	20	100000	µs/V
$\Delta t/\Delta v$	Input transition rise or fall rate	V_{CC} = 1.5V to 5.5V		100	ms/V
T_A	Operating free-air temperature	Operating free-air temperature	−40	125	°C

(1) All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation.
(2) Recommended R_{ext} and C_{ext} values maintain maximum error provided as Δt_{wo} in the *Switching Characteristics* table.
(3) Recommended maximum output current for continuous operation; see *Electrical Characteristics* for test current values to maintain V_{OH} and V_{OL} specifications.

5.4 Thermal Information

PACKAGE	PINS	THERMAL METRIC[1]						UNIT
		$R_{\theta JA}$	$R_{\theta JC(top)}$	$R_{\theta JB}$	Ψ_{JT}	Ψ_{JB}	$R_{\theta JC(bot)}$	
PW (TSSOP)	16	138.3	75.1	96.5	19.4	95.5	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application note.

5.5 Electrical Characteristics

Over operating free-air temperature range; typical values measured at T_A = 25°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS	V_{CC}	MIN	TYP	MAX	UNIT
V_{T+}	Positive switching threshold		1.5V	0.65	0.84	0.96	V
			1.8V	0.73	0.95	1.11	
			2.5V	0.88	1.11	1.33	
			3.3V	1.03	1.27	1.5	
			5V	1.33	1.58	1.82	
			5.5V	1.41	1.67	1.91	
V_{T-}	Negative switching threshold		1.5V	0.32	0.41	0.5	V
			1.8V	0.36	0.46	0.53	
			2.5V	0.45	0.55	0.63	
			3.3V	0.54	0.65	0.74	
			5V	0.7	0.85	0.96	
			5.5V	0.74	0.89	1.02	

ADVANCE INFORMATION

Over operating free-air temperature range; typical values measured at T_A = 25°C (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	V_{CC}	MIN	TYP	MAX	UNIT
ΔV_T	Hysteresis (V_{T+} - V_{T-})		1.5V	0.33	0.45	0.6	V
			1.8V	0.36	0.5	0.65	
			2.5V	0.42	0.56	0.72	
			3.3V	0.49	0.62	0.78	
			5V	0.61	0.74	0.91	
			5.5V	0.65	0.77	0.95	
V_{OH}	High-level output voltage	I_{OH} = -50µA	1.5V - 5.5V	V_{CC} – 0.1	V_{CC} – 0.01		V
		I_{OH} = -1mA	1.65V	1.2	1.61		
		I_{OH} = -2mA	2.3V	2.1	2.24		
		I_{OH} = -8mA	3V	2.4	2.78		
		I_{OH} = -12mA	4.5V	3.94	4.21		
		I_{OH} = -12mA	5.5V	4.94	5.23		
V_{OL}	Low-level output voltage	I_{OL} = 50µA	1.5V - 5.5V		0.01	0.1	V
		I_{OL} = 1mA	1.65V		0.03	0.45	
		I_{OL} = 2mA	2.3V		0.04	0.2	
		I_{OL} = 8mA	3V		0.13	0.4	
		I_{OL} = 12mA	4.5V		0.15	0.5	
		I_{OL} = 12mA	5.5V		0.13	0.5	
I_I	Input leakage current	V_I = 5.5V or 0V	0V to 5.5V			±50	nA
I_{CEXT}	Capacitor pin current	Monitor state, V_{CEXT} = 0.5 × V_{CC}	1.5V to 5.5V			±50	nA
I_{CEXT}	Capacitor pin current	Active state, discharging, V_{CEXT} = 1.5V	1.5V			11	mA
		Active state, discharging, V_{CEXT} = 2.3V	2.3V			29	mA
		Active state, discharging, V_{CEXT} = 3V	3V			45	mA
		Active state, discharging, V_{CEXT} = 4.5V	4.5V			95	mA
		Active state, discharging, V_{CEXT} = 5.5V	5.5V			138	mA
I_{off}	Partial power-off current	V_I or V_O = 5.5V or 0V	0V to 0.3V		0.25	10	µA
I_{CC}	Supply current	Ready state, V_I = V_{CC} or 0V, I_O = 0	5.5V		0.19	2	µA
I_{CC}	Supply current	Active state per channel, V_I = V_{CC} or 0V, I_O = 0	1.5V			180	µA
			1.65V			200	
			2.3V			290	
			3V			450	
			4.5V			836	
			5.5V			1126	
ΔI_{CC}	Supply-current change	One input, V_i = 0 to V_{CC}, all other inputs at V_{CC} or 0V, I_O = 0mA	1.5V to 5.5V			2	mA
C_I	Input capacitance	V_I = 5.5V or 0V	5.5V		1		pF
C_O	Output capacitance	V_O = 5.5V or 0V	0V		3		pF

ADVANCE INFORMATION

Product Folder Links: *TPUL2T323*

Over operating free-air temperature range; typical values measured at T_A = 25°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS	V_{CC}	MIN	TYP	MAX	UNIT
C_{int}	Internal capacitance	C_{ext} = 0pF; V_{cext} = 0 to V_{CC}	1.5V	16	17.9	20	pF
			1.65V	14	15.5	17	
			2.3V	7	9.7	13	
			3V	6	9.9	14	
			4.5V	5	7.7	10	
			5.5V	4	5.7	7	

5.6 Timing Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	DESCRIPTION	CONDITION	V_{CC}	MIN	MAX	UNIT
t_{wi}	Pulse duration	Any trigger input	1.5V	18.2		ns
			1.8V ± 0.15V	9.9		
			2.5V ± 0.2V	7.8		
			3.3V ± 0.3V	5.8		
			5V ± 0.5V	4.1		
t_{su}	Setup time between trigger inputs	$\overline{T}$ low before T↑ or $\overline{CLR}$↑	1.5V	9.6		ns
			1.8V ± 0.15V	8		
			2.5V ± 0.2V	6.9		
			3.3V ± 0.3V	6.6		
			5V ± 0.5V	6.5		
		T high before $\overline{T}$↓ or $\overline{CLR}$↑	1.5V	5		ns
			1.8V ± 0.15V	5		
			2.5V ± 0.2V	5		
			3.3V ± 0.3V	5		
			5V ± 0.5V	5		
		$\overline{CLR}$ high before $\overline{T}$↓ or T↑	1.5V	9.2		ns
			1.8V ± 0.15V	7.8		
			2.5V ± 0.2V	6.7		
			3.3V ± 0.3V	6.5		
			5V ± 0.5V	6.4		
t_h	Hold time	Any trigger input	1.5V	9.3		ns
			1.8V ± 0.15V	7.8		
			2.5V ± 0.2V	6.7		
			3.3V ± 0.3V	6.5		
			5V ± 0.5V	6.4		

ADVANCE INFORMATION

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	DESCRIPTION	CONDITION	V_{CC}	MIN	MAX	UNIT
t_{rr}	Retrigger time	Any trigger input, R_{ext} = 100kΩ, C_{ext} = 100pF	1.5V		13.1	µs
			1.8V ± 0.15V		13	
			2.5V ± 0.2V		12.6	
			3.3V ± 0.3V		12.5	
			5V ± 0.5V		12.2	
		Any trigger input, R_{ext} = 10kΩ, C_{ext} = 0.1µF	1.5V		1.91	ms
			1.8V ± 0.15V		1.89	
			2.5V ± 0.2V		1.87	
			3.3V ± 0.3V		1.85	
			5V ± 0.5V		1.81	
		Any trigger input, R_{ext} = 10kΩ, C_{ext} = 10µF	1.5V		912	ms
			1.8V ± 0.15V		911	
			2.5V ± 0.2V		904	
			3.3V ± 0.3V		893	
			5V ± 0.5V		864	
$t_{startup}$ [(1)]	Startup time		1.5V to 5.5V		200	µs

(1)   Triggers are ignored during startup time
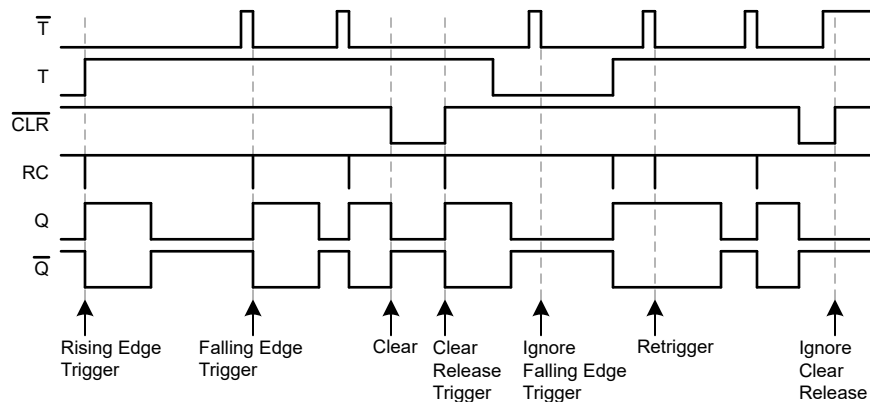
Figure 5-1. Input/Output Timing Diagram

5.7 Switching Characteristics

over operating free-air temperature range; typical values measured at T_A = 25°C (unless otherwise noted). See *Parameter Measurement Information*.

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	V_{CC}	MIN	TYP	MAX	UNIT
C_L = 15pF								
t_{pd}	$\overline{T}$, T, or $\overline{CLR}$	Q or $\overline{Q}$	C_L = 15pF	1.5V	7	35	59	ns
				1.65V	6	28.6	47	
				2.3V	4	16.6	26	
				3V	3	12.4	19	
				4.5V	2	9.4	13	
				5.5V	2	9.2	12	

over operating free-air temperature range; typical values measured at $T_A = 25°C$ (unless otherwise noted). See *Parameter Measurement Information*.

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	V_{CC}	MIN	TYP	MAX	UNIT
t_t		Q or $\overline{Q}$	$C_L = 15pF$	1.5V		4.3	8.3	ns
				1.65V		3.9	7	
				2.3V		3	5.6	
				3V		2.5	5	
				4.5V		2.4	4.9	
				5.5V		2.7	5.8	
$C_L = 50pF$								
t_{pd}	$\overline{T}$, T, or $\overline{CLR}$	Q or $\overline{Q}$	$C_L = 50pF$	1.5V	7	37	67	ns
				1.65V	6	30.2	53	
				2.3V	4	17.6	30	
				3V	3	13	22	
				4.5V	2	9.8	16	
				5.5V	2	9.6	14	
t_{wo} [1]		Q or $\overline{Q}$	$R_{ext} = 1M\Omega$; $C_{ext} = 0$; $C_L = 50pF$	1.5V	2.8	3.6	4.4	ms
				1.65V	2.8	3.6	4.3	
				2.3V	2.7	3.4	4.1	
				3V	2.6	3.3	4	
				4.5V	2.5	3.2	3.8	
				5.5V	2.4	3.1	3.8	
			$R_{ext} = 10k\Omega$; $C_{ext} = 0.1\mu F$; $C_L = 50pF$	1.5V	831	924	1017	ms
				1.65V	832	925	1018	
				2.3V	837	931	1024	
				3V	842	936	1030	
				4.5V	852	948	1043	
				5.5V	857	953	1049	
			$R_{ext} = 330k\Omega$; $C_{ext} = 1\mu F$; $C_L = 50pF$	1.5V	262	292	322	s
				1.65V	253	282	311	
				2.3V	255	284	313	
				3V	255	284	312	
				4.5V	261	290	319	
				5.5V	264	294	323	
Δt_{wo} [2]		Q or $\overline{Q}$	$C_L = 50pF$	1.5V to 5.5V		±5	±10	%
t_t		Q or $\overline{Q}$	$C_L = 50pF$	1.5V		8.2	34.4	ns
				1.65V		7	28	
				2.3V		4.5	24.6	
				3V		3.9	17.4	
				4.5V		3.1	12.6	
				5.5V		2.9	8.7	

ADVANCE INFORMATION

over operating free-air temperature range; typical values measured at T_A = 25°C (unless otherwise noted). See *Parameter Measurement Information*.

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	V_{CC}	MIN	TYP	MAX	UNIT
C_{pd} [3]	$\overline{CLR}$		$T = V_{CC}$, $\overline{T}$ = GND f_I = 10MHz C_L = 50pF C_{ext} = 0pF R_{ext} = 1MΩ	1.5V		46		pF
				1.65V		46		
				2.3V		49		
				3V		40		
				4.5V		47		
				5.5V		49		

(1)   Output pulse width
(2)   Variation in output pulse width as compared to typical characteristics for K factor excluding variations in external timing components.
(3)   Power dissipation capacitance is calculated in accordance with CMOS Power Consumption and Cpd Calculation.

ADVANCE INFORMATION

Product Folder Links: *TPUL2T323*

5.8 Typical Characteristics

T_A = 25°C (unless otherwise noted)

Note
The TPUL family of devices are in early release. Preliminary data is provided.

Table 5-1. Pulse width using common RC, V_{CC} = 3.3V

Resistor Value	Capacitor Value						
	10µF	1µF	100nF	10nF	1nF	100pF	10pF
1kΩ	9.74s	974ms	102ms	10.5ms	1.17ms[1]	172µs[1]	59.5µs[1]
1.5kΩ	14.4s	1.44s	1.47ms	15.3ms	1.67ms[1]	232µs[1]	66.8µs[1]
2.2kΩ	20.9s	2.09s	212ms	21.8ms	2.4ms[1]	318µs[1]	81.4µs[1]
3.3kΩ	30.8s	3.08s	313ms	32.3ms	3.5ms[1]	450µs[1]	98.5µs[1]
4.7kΩ	43.5s	4.35s	442ms	45.4ms	4.95ms[1]	618µs[1]	120µs[1]
6.8kΩ	62.7s	6.27s	636ms	65.4ms	7.08ms[1]	869µs[1]	151µs[1]
10kΩ	91.4s	9.14s	929ms	95.6ms	10.3ms	1.25ms[1]	199µs[1]
15kΩ	137s	13.7s	1.38s	143ms	15.5ms	1.84ms[1]	270µs[1]
22kΩ	201s	20.1s	2.04s	210ms	22.5ms	2.68ms[1]	372µs[1]
33kΩ	301s	30.1s	3.04s	314ms	33.9ms	3.98ms[1]	530µs[1]
47kΩ	427s	42.7s	4.33s	446ms	47.9ms	5.65ms[1]	733µs[1]
68kΩ	620s	62s	6.27s	644ms	69.5ms	8.14ms[1]	1.02ms[1]
100kΩ	909s	90.9s	9.22s	947ms	102ms	12ms	1.5ms[1]
150kΩ	1360s	136s	13.8s	1.42s	154ms	17.8ms	2.2ms[1]
220kΩ	2000s	200s	20.2s	2.09s	225ms	26.2ms	3.19ms[1]
330kΩ	2924s[2]	300s	30.3s	3.12s	338ms	39ms	4.75ms[1]
470kΩ	2939s[2]	427s	43.2s	4.46s	481ms	55.8ms	6.75ms[1]
680kΩ	2962s[2]	618s	62.4s	6.43s	696ms	81.1ms	9.73ms[1]
1MΩ	2995s[2]	904s	92.1s	9.5s	1.02s	120ms	14.2ms

(1) Pulse widths configured for less than 10ms (K×R×C < 10µs) can fail to properly trigger the state machine resulting in very short output pulses (t_{wo} < 10µs).
(2) Pulse widths configured for more than 2253s (K×R×C > 2.2s) can vary significantly due to exceeding the digital timing circuitry capabilities.
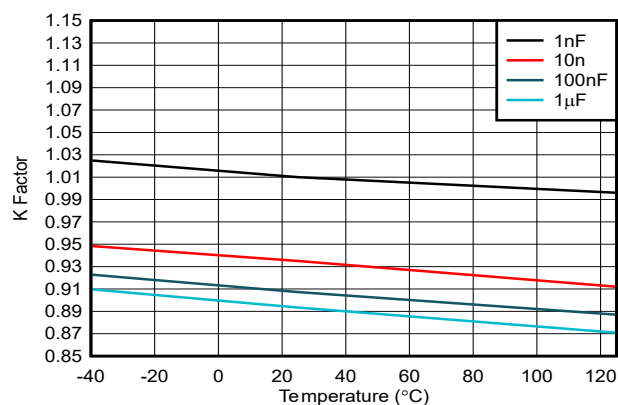
Figure 5-2. K Factor vs Temperature, R_{ext} = 10kΩ
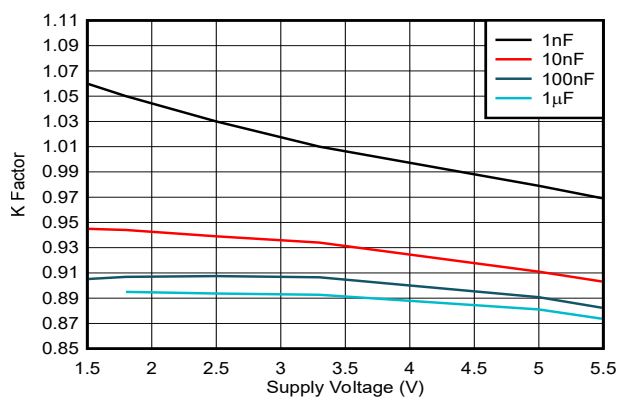
Figure 5-3. K Factor vs Supply Voltage, R_{ext} = 10kΩ

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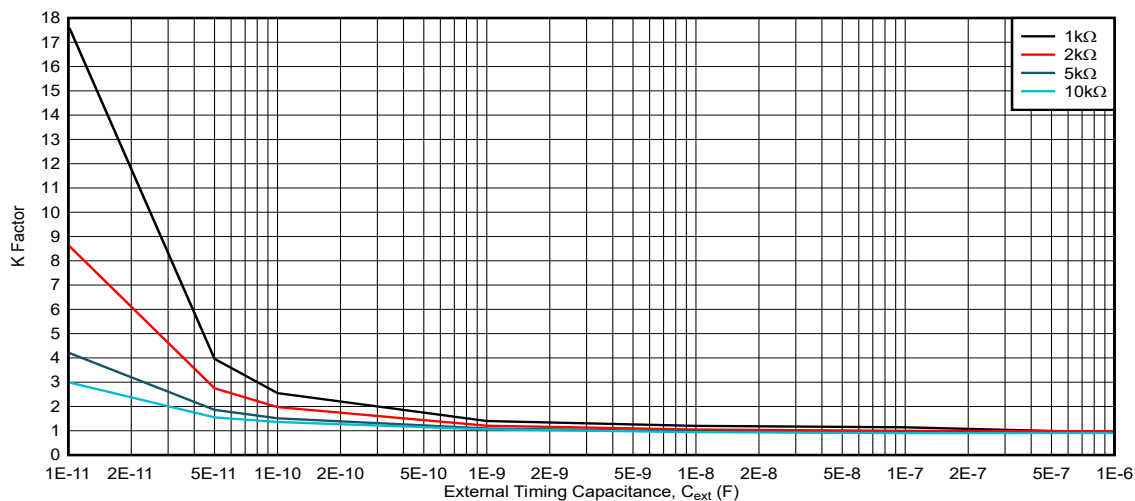
Figure 5-4. K Factor, V$_{CC}$ = 1.5V, R$_{ext}$ = 1kΩ to 10kΩ
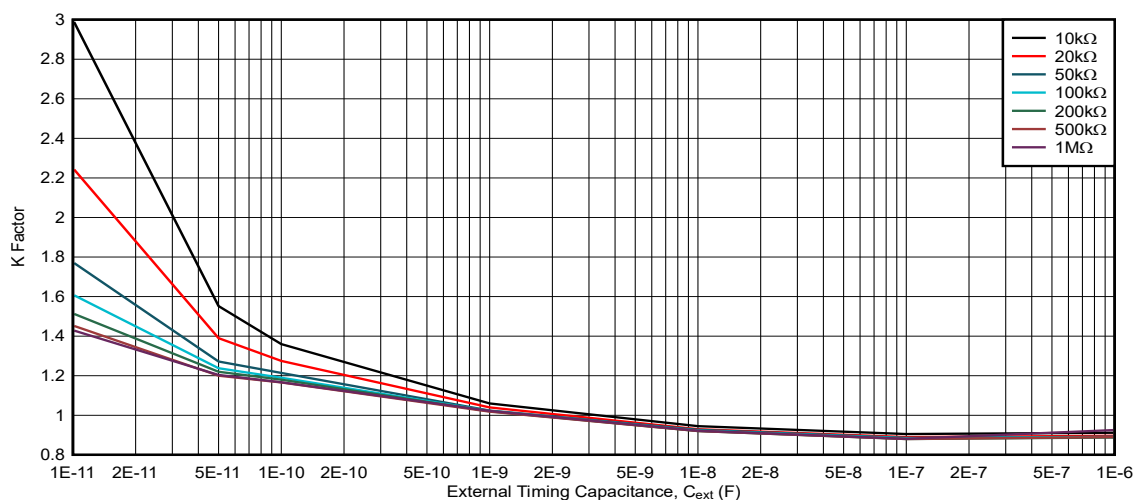
Figure 5-5. K Factor, V$_{CC}$ = 1.5V, R$_{ext}$ = 10kΩ to 1MΩ
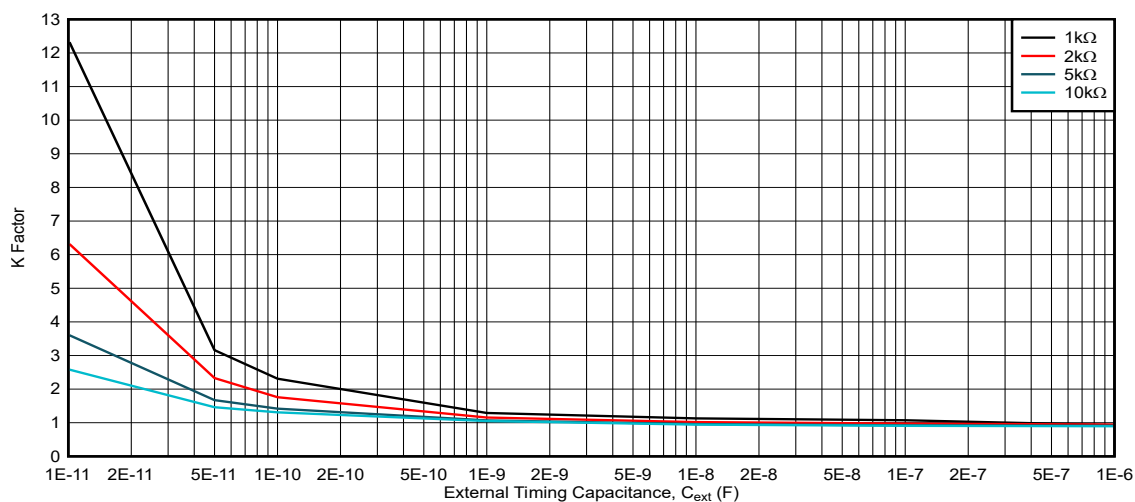
Figure 5-6. K Factor, V$_{CC}$ = 1.8V, R$_{ext}$ = 1kΩ to 10kΩ

Product Folder Links: *TPUL2T323*
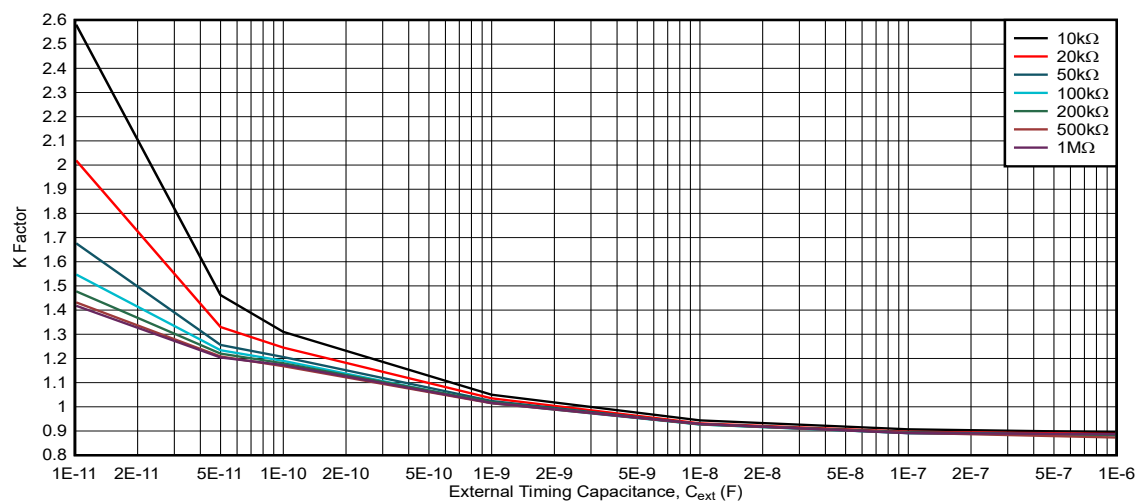
Figure 5-7. K Factor, V_{CC} = 1.8V, R_{ext} = 10kΩ to 1MΩ
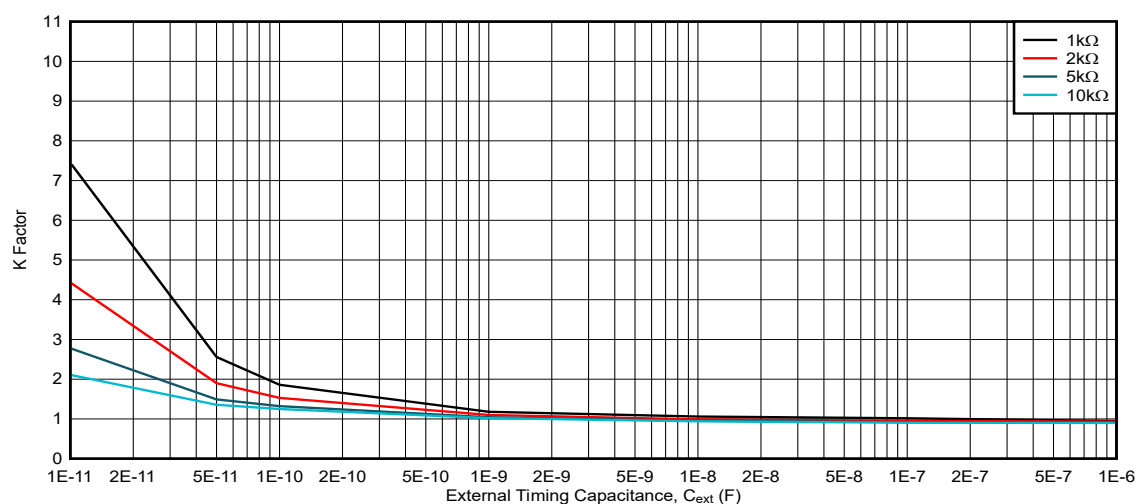
Figure 5-8. K Factor, V_{CC} = 2.5V, R_{ext} = 1kΩ to 10kΩ
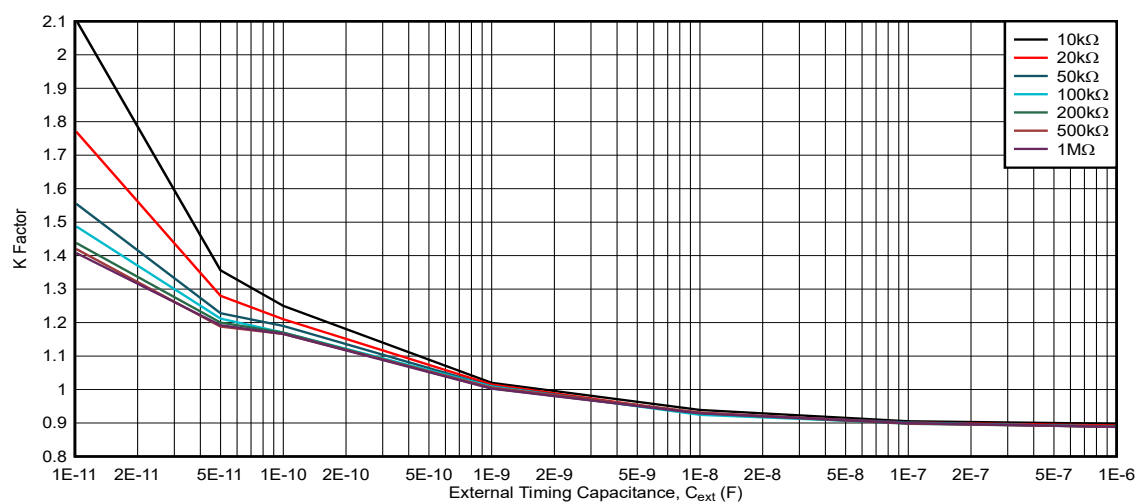
Figure 5-9. K Factor, V_{CC} = 2.5V, R_{ext} = 10kΩ to 1MΩ

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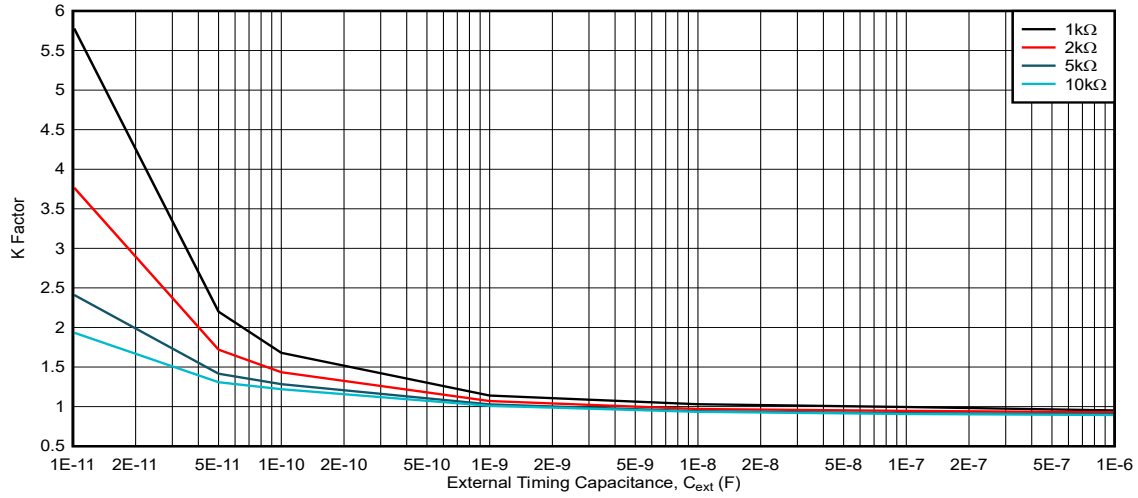
Figure 5-10. K Factor, V_{CC} = 3.3V, R_{ext} = 1kΩ to 10kΩ
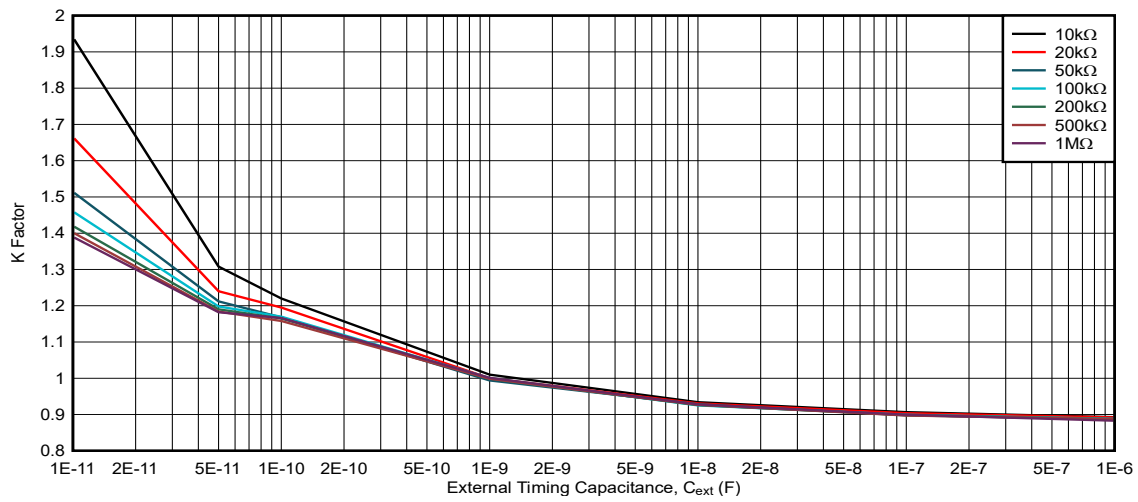
Figure 5-11. K Factor, V_{CC} = 3.3V, R_{ext} = 10kΩ to 1MΩ
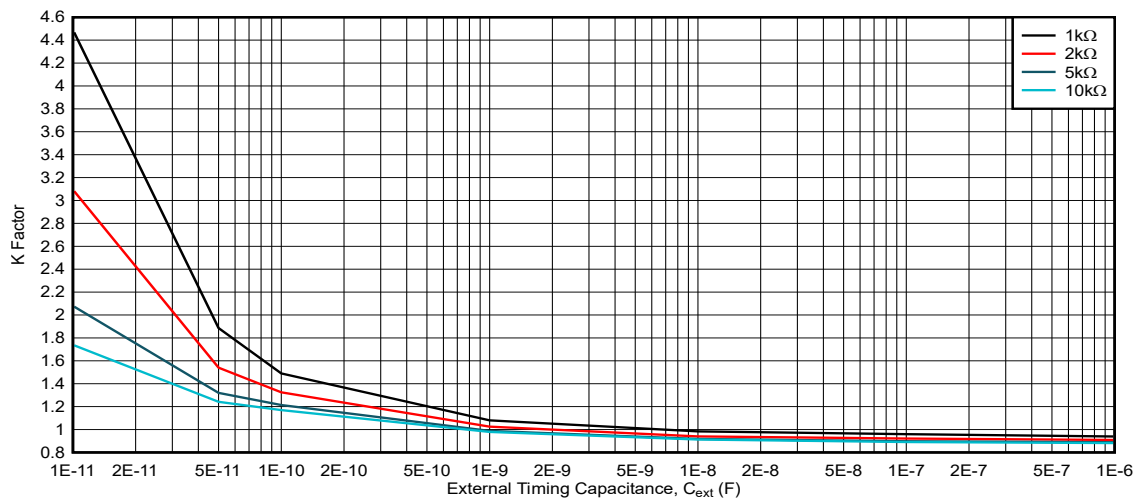
Figure 5-12. K Factor, V_{CC} = 5V, R_{ext} = 1kΩ to 10kΩ
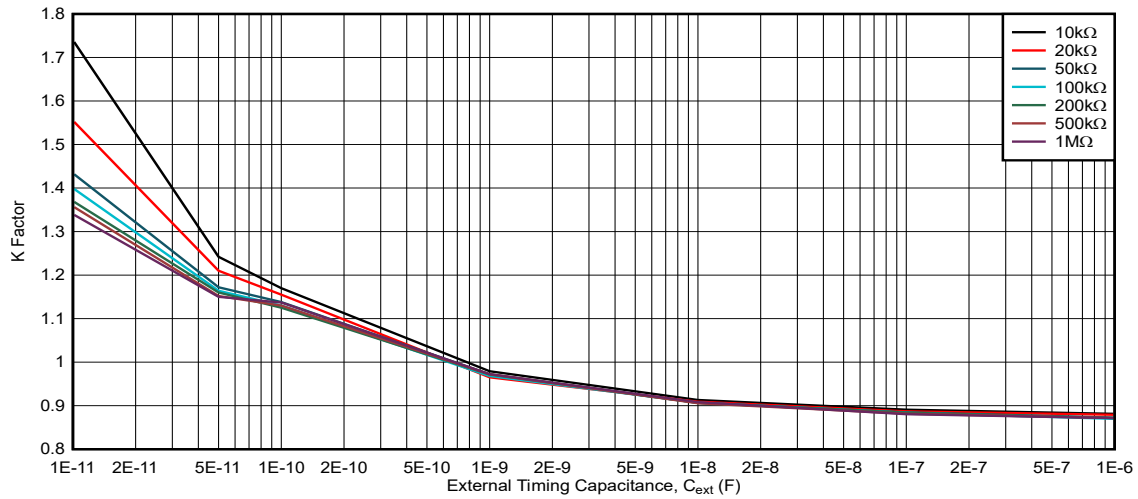
Figure 5-13. K Factor, V_{CC} = 5V, R_{ext} = 10kΩ to 1MΩ
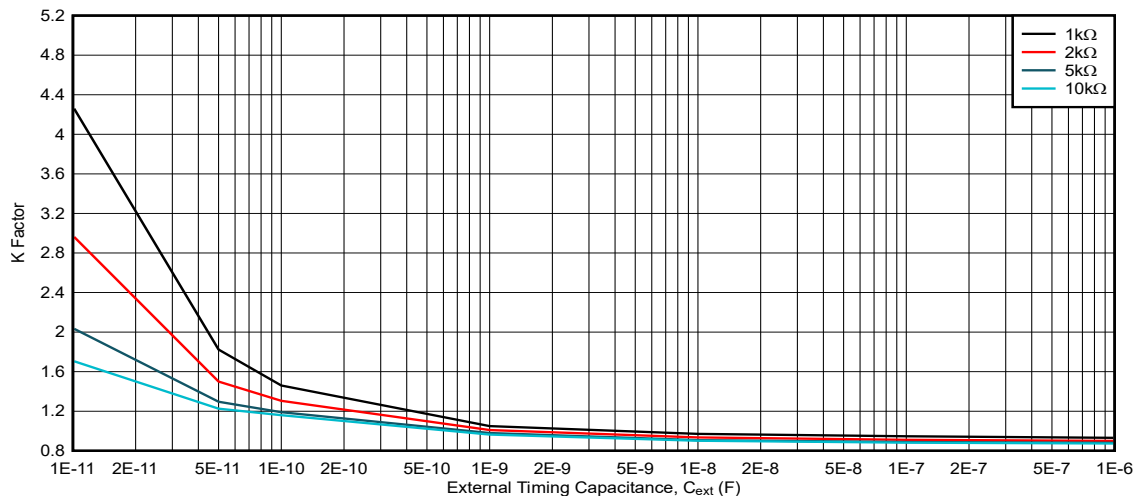
Figure 5-14. K Factor, V_{CC} = 5.5V, R_{ext} = 1kΩ to 10kΩ
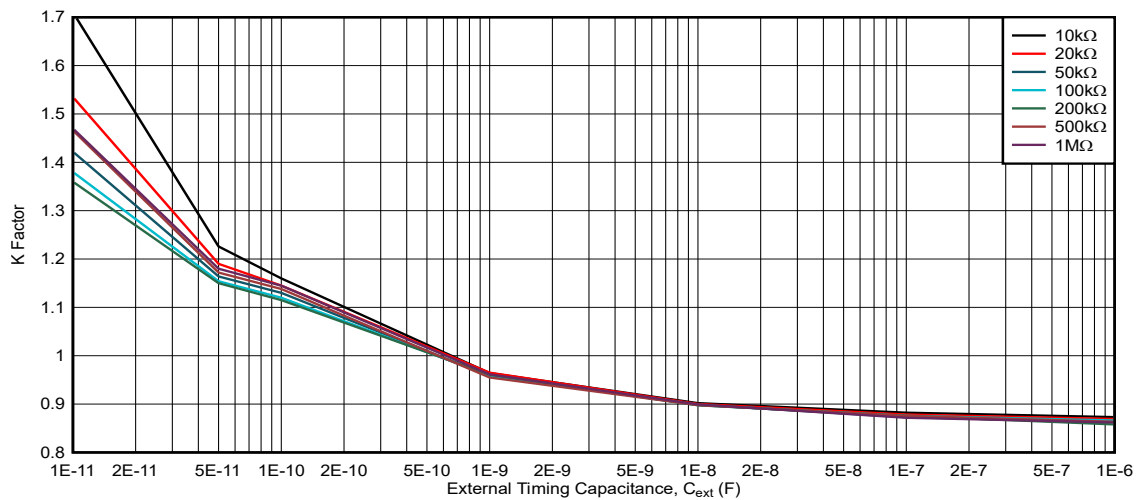
Figure 5-15. K Factor, V_{CC} = 5.5V, R_{ext} = 10kΩ to 1MΩ

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Product Folder Links: *TPUL2T323*

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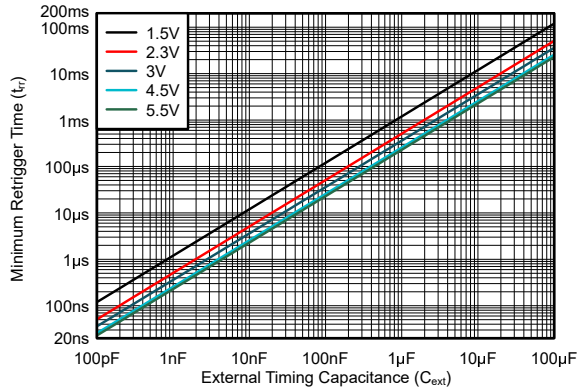
Figure 5-16. Minimum retrigger time versus external timing capacitor value
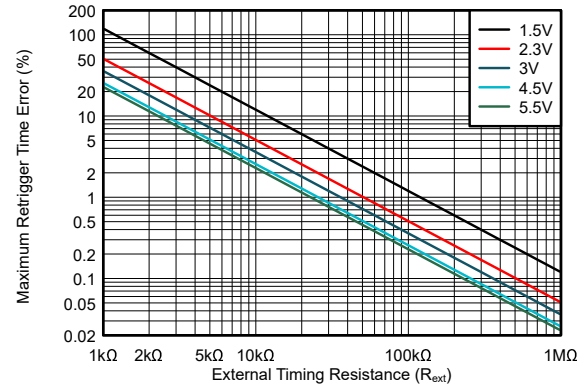
Figure 5-17. Maximum retrigger time error as a percentage of total pulse width versus external timing resistor value

Error data in the following plots indicates changes from typical behavior (nominal material, $T_A = 25°C$) due to variation in manufacturing process and operating free-air temperature.
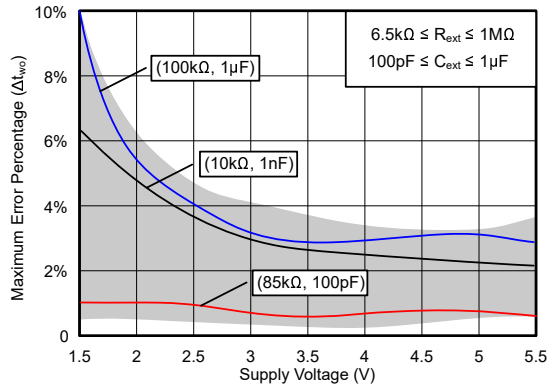
Figure 5-18. Maximum output pulse width error (absolute value) across supply voltage
Each line: one timing component combination
Shaded area: all timing component combinations
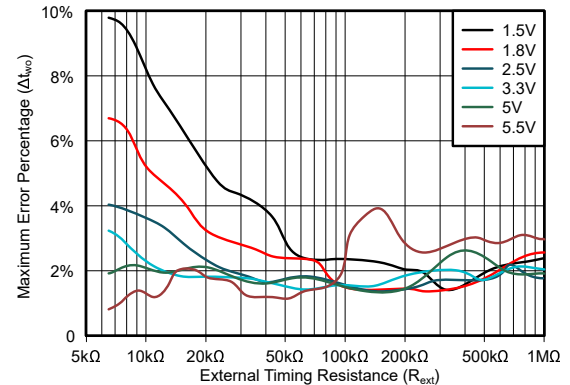
Figure 5-19. Maximum output pulse width error (absolute value) versus timing resistor values with C_{ext} = 100pF
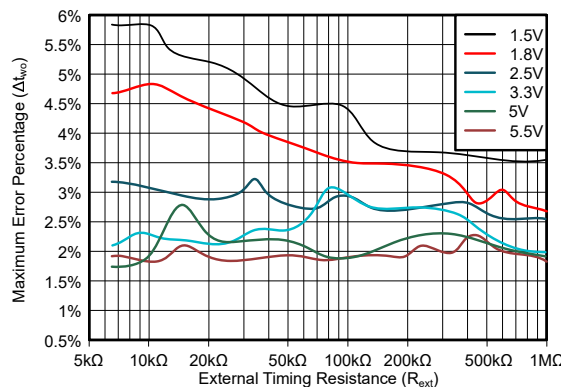
Figure 5-20. Maximum output pulse width error (absolute value) versus timing resistor values with C_{ext} = 1nF

6 Parameter Measurement Information

Phase relationships between waveforms were chosen arbitrarily for the examples listed in the following table. All input pulses are supplied by generators having the following characteristics: PRR ≤ 1MHz, $Z_O = 50\Omega$, $t_t < 2.5ns$.

The outputs are measured individually with one input transition per measurement.
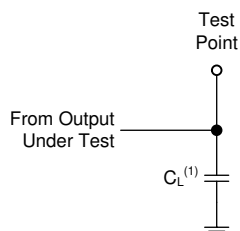
(1) C_L includes probe and test-fixture capacitance.
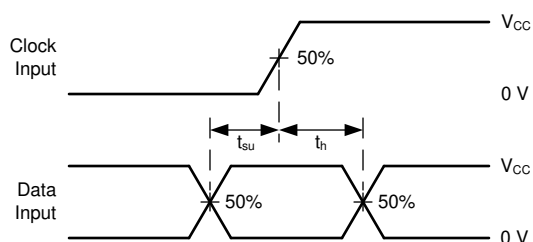
Figure 6-1. Load Circuit for Push-Pull Outputs

Figure 6-2. Voltage Waveforms, Pulse Duration

Figure 6-3. Voltage Waveforms, Setup and Hold Times
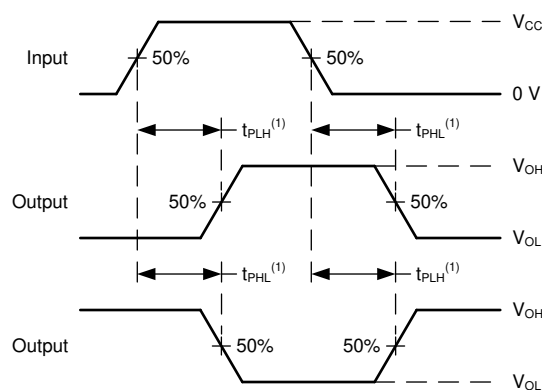
(1) The greater between t_{PLH} and t_{PHL} is the same as t_{pd}.

Figure 6-4. Voltage Waveforms Propagation Delays
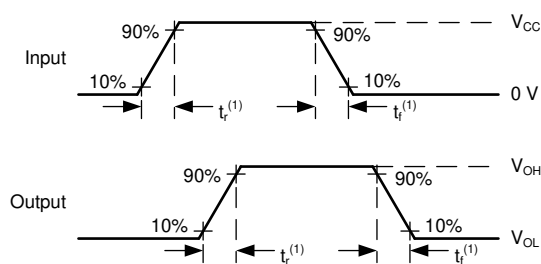
(1) The greater between t_r and t_f is the same as t_t.

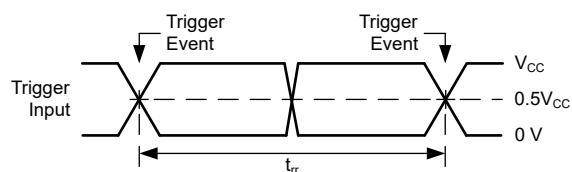**Figure 6-5. Voltage Waveforms, Input and Output Transition Times**

Figure 6-6. Voltage Waveforms, Retrigger Time

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7 Detailed Description

7.1 Overview

The TPUL2T323 device contains two independent extended-pulse-width retriggerable monostable multivibrator circuits. A monostable multivibrator, also commonly known as a "one shot," produces a single digital pulse when triggered and otherwise maintains a constant output state.

The TPUL2T323 device features three gated trigger inputs for each channel. For a rising edge trigger, the T or $\overline{\text{CLR}}$ input is used. For a falling edge trigger the $\overline{\text{T}}$ input is used.

The TPUL2T323 device includes an asynchronous clear input ($\overline{\text{CLR}}$) that can be used to terminate an ongoing output pulse.

When triggered, the TPUL2T323 outputs a positive digital pulse with pulse width defined as $t_{wo} = 1024 \times K \times R_{ext} \times C_{ext}$, with R_{ext} and C_{ext} being the external timing resistor and external timing capacitor component values measured in Ω and F, respectively, and K being a unitless nonlinearity correction factor provided in the *Typical Characteristics* section. The external timing components must be connected as shown in Figure 7-1. The external ground connection to the C terminal is optional.
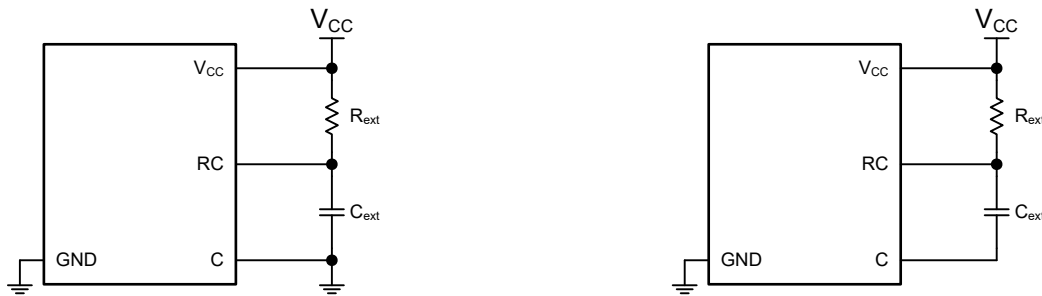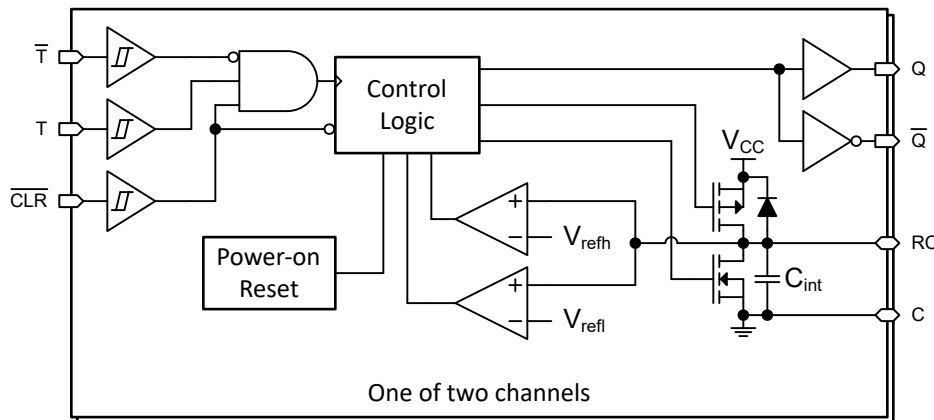

Figure 7-1. Timing component connection, with and without external ground

7.2 Functional Block Diagram

$V_{refh} = 0.69 \times V_{CC}$

$V_{refl} = 0.25 \times V_{CC}$

C_{int} indicates total internal parasitic capacitance and can be found in the *Electrical Characteristics* table.

One of two channels

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7.3 Feature Description

7.3.1 Naming Convention

| T | P | U | L | 2 | G | 1 | 2 | 3 | – | Q | 1 |

Product Group	Channels	Thresholds	Timing Type	Output(s)	Input(s)	Rating
TPUL	2	G : Standard T : Reduced	1 : RC 1x, Retrig 2 : RC 1x, Non-retrig 3 : RC 1000x, Retrig	0 : Active Low 1 : Active High 2 : Both	0 : Falling edge (FE) 1 : Rising edge (RE) 2 : FE, RE, async clear 3 : FE, RE, async clear, and trigger on clear release	[none] : Commercial / Industrial -Q1 : Automotive, AEC-Q100
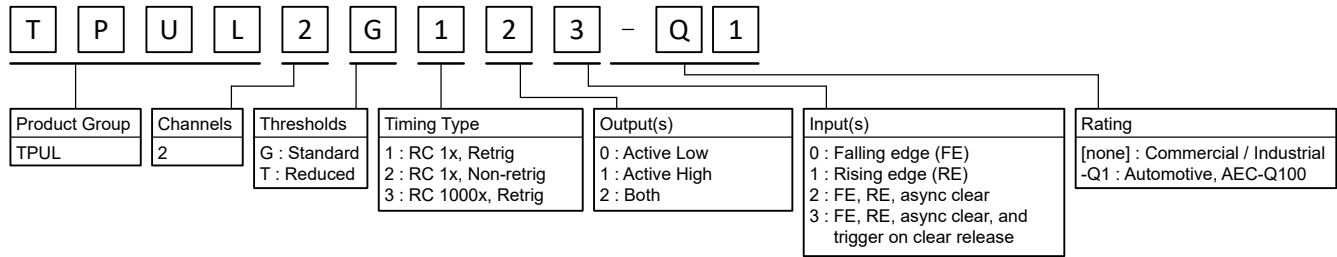
Figure 7-2. Device name meaning

7.3.2 Retriggerable One-Shot

This device includes a retriggerable monostable multivibrator (one-shot) circuit that produces a fixed-width output pulse. The output pulse width for a retriggerable one-shot is extended by additional input triggers while the output is active. The output pulse will expire after the configured time period if no other triggers have been received.

The output pulse width after a retrigger event is always shorter than the normal output pulse width because the timing capacitor does not need to be fully discharged for a retrigger event. The maximum error due to this change is the time to discharge the selected timing capacitor. The error due to retrigger timing can be minimized by selecting larger resistor values and smaller capacitor values for a given pulse width. See retrigger plots in the *Typical Characteristics* section for more details.

7.3.3 Extended RC Timed One-Shot

The output pulse width (t_{wo}) is controlled by the selection of external timing components R_{ext} and C_{ext}. The TPUL2T323 has been designed to target a typical output pulse width of $t_{wo} \cong 1000 \times R_{ext} \times C_{ext}$, however the actual pulse width changes with multiple variables, and thus a nonlinearity correction factor, K, is added to provide the system designer with a more accurate pulse width estimation. Equation 1 is used to most accurately predict the output pulse width.

$$t_{wo} = K \times 1024 \times R_{ext} \times C_{ext} \tag{1}$$

The output pulse width is dependent on multiple variables:

- External timing components (R_{ext}, C_{ext})
- Voltage
- Temperature
- Manufacturing and design
- Digital state machine operation

The external timing component values directly control the output pulse width, and any variations in component values due to manufacturing, voltage, or temperature will directly impact the output pulse width.

Most resistors maintain very consistent values during operation, and thus tend to have little impact on accuracy.

Most capacitors have a wide variation of manufacturing values, and additionally can vary due to temperature and operating voltage. Typically, the timing capacitor is the largest single source of error for RC timed monostable multivibrators.

There is also some error introduced by the TPUL2T323. This error is provided as Δt_{wo} in the *Switching Characteristics* section and includes variations due to digital state machine operation, design, manufacturing, and temperature. There is additionally some randomness inherent to the pulse width even with all other factors held constant which is typically less than 1% and is accounted for in the Δt_{wo} specification.

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Estimating the percent error of the output pulse width ($e_{\Delta two}$) requires multiple inputs. Equation 2 provides the best method to estimate total pulse width error due to tolerance of components, with e_R being the error introduced by the timing resistor, e_C being the error introduced by the timing capacitor, and Δt_{wo} being the error introduced by the TPUL2T323.

$$e_{\Delta two} = e_R + e_C + e_R e_C + \Delta t_{wo}(1 + e_R + e_C + e_R e_C) \qquad (2)$$

For a quick estimate, the sum of the error values can be used ($e_{\Delta two} \cong e_R + e_C + \Delta t_{wo}$). For example, a typical TPUL2T323 application circuit using an X7R capacitor (5% manufacturing tolerance + 15% temperature variation), 0.1% resistor, and Δt_{wo} of 5% would have a quickly estimated maximum error of 25.1%. With the more accurate equation, the maximum error is actually 26.126%.

7.3.4 Balanced CMOS Push-Pull Outputs

This device includes balanced CMOS push-pull outputs. The term *balanced* indicates that the device can sink and source similar currents. The drive capability of this device may create fast edges into light loads, so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device are capable of driving larger currents than the device can sustain without being damaged. It is important to limit the output power of the device to avoid damage due to overcurrent. The electrical and thermal limits defined in the *Absolute Maximum Ratings* must be followed at all times.

Unused push-pull CMOS outputs must be left disconnected.

7.3.5 CMOS Schmitt-Trigger Inputs

This device includes inputs with the Schmitt-trigger architecture. These inputs are high impedance and are typically modeled as a resistor in parallel with the input capacitance given in the *Electrical Characteristics* table from the input to ground. The worst case resistance is calculated with the maximum input voltage, given in the *Absolute Maximum Ratings* table, and the maximum input leakage current, given in the *Electrical Characteristics* table, using Ohm's law (R = V ÷ I).

The Schmitt-trigger input architecture provides hysteresis as defined by ΔV_T in the *Electrical Characteristics* table, which makes this device extremely tolerant to slow or noisy inputs. While the inputs can be driven much slower than standard CMOS inputs, it is still recommended to properly terminate unused inputs. Driving the inputs with slow transitioning signals will increase dynamic current consumption of the device with the maximum value per input defined as ΔI_{CC} in the *Electrical Characteristics* table. For additional information regarding Schmitt-trigger inputs, please see *Understanding Schmitt Triggers*.

Do not leave inputs floating at any time during operation. Unused inputs must be terminated at a valid high or low voltage level. If a system is not actively driving an input at all times, then a pull-up or pull-down resistor can be added to provide a valid input voltage during these times. The resistor value will depend on multiple factors; however, a 10kΩ resistor is recommended and will typically meet all requirements.

7.3.6 Latching Logic with Known Power-Up State

This device includes latching logic circuitry. Latching circuits commonly include D-type latches and D-type flip-flops, but include all logic circuits that act as volatile memory. In typical logic devices, the output state of each latching circuit is unknown after power is initially applied; however, this device includes an added Power On Reset (POR) circuit which sets the states of all included latching circuits during the power-up ramp prior to the device starting normal functionality.
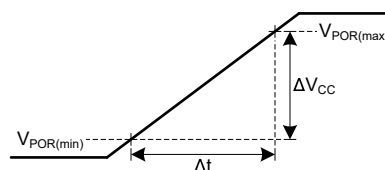

Figure 7-3. Supply (V_{CC}) Ramp Characteristics for Known Power-Up State

Figure 7-3 shows a correct supply voltage turn-on ramp and defines values used in the *Recommended Operating Conditions* and *Electrical Characteristics* tables.

Prior to starting the power-on ramp, the supply must be completely off ($V_{CC} \leq V_{POR(min)}$).

The supply voltage must ramp at a rate within the range provided in the *Recommended Operating Conditions* table.

The output state of each latching logic circuit only remains stable as long as power is applied to the device ($V_{CC} \geq V_{POR(max)}$).

Variation from these recommendations will result in the device having an unknown power-up state.

7.3.7 Partial Power Down (I_{off})

This device includes circuitry to disable all outputs when the supply pin is held at 0V. When disabled, the outputs will neither source nor sink current, regardless of the input voltages applied. The amount of leakage current at each output is defined by the I_{off} specification in the *Electrical Characteristics* table.

7.3.8 Reduced Input Threshold Voltages

The TPUL2T323 was designed with reduced input voltage thresholds to support up-translation and inputs tolerant to 5.5V signal levels to support down-translation. For proper functionality, input signals must remain at or above the specified $V_{T+(MAX)}$ (V_{IH}) level for a HIGH input state, and at or below the specified $V_{T-(MIN)}$ (V_{IL}) for a LOW input state. Figure 7-4 shows the typical V_{IH} and V_{IL} levels for TPULxT devices, as well as the voltage levels for standard CMOS devices for comparison.
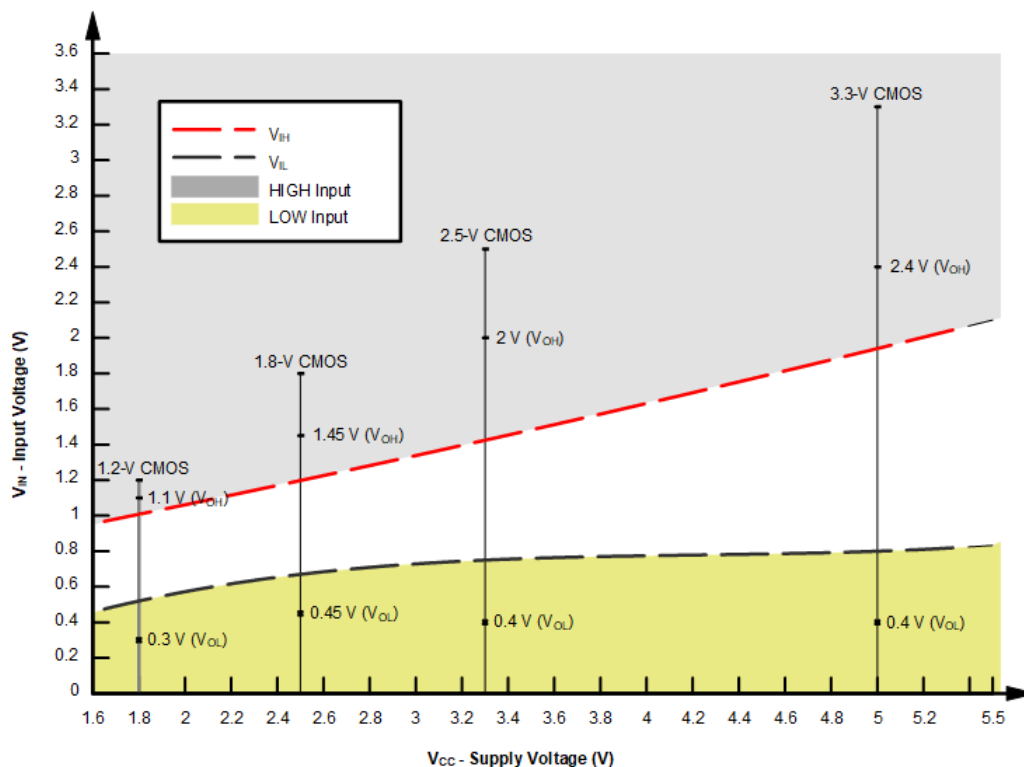

Figure 7-4. TPULxT Input Voltage Levels

7.3.9 Clamp Diode Structure

Figure 7-5 shows the inputs and outputs to this device have negative clamping diodes only.

Product Folder Links: *TPUL2T323*

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> **CAUTION**
>
> Voltages beyond the values specified in the *Absolute Maximum Ratings* table can cause damage to the device. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
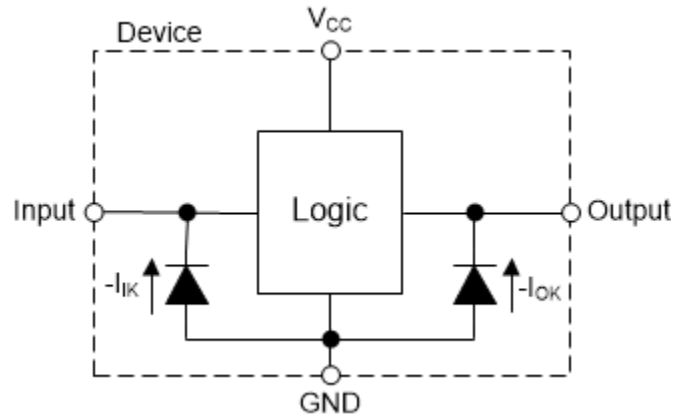

Figure 7-5. Electrical Placement of Clamping Diodes for Each Input and Output

7.4 Device Functional Modes

7.4.1 Off-State Operation

The TPUL2T323 includes partial-power-down (I_{off}) protection, which forces the outputs into a high-impedance state when the supply voltage is approximately 0V. In the powered-off state, voltages can be applied to the digital inputs and outputs and the device will not respond or have any back-powering. This protection does not apply to the RC pin.

7.4.2 Startup Operation

The TPUL2T323 includes an internal power-on reset (POR) circuit that prevents erroneous triggers from occurring during startup. There are details on the supply ramp requirements provided in *Latching Logic with Known Power-Up State*. Normal operation can be started after the startup time ($t_{startup}$) has expired per the *Timing Requirements* table. While active, the POR circuit holds the TPUL2T323 in the *Ready* state.

7.4.3 On-State Operation

The table below lists the on-state functional modes for the TPUL2T323.

Table 7-1. Function Table

INPUTS[1]			OUTPUTS[2]	
$\overline{CLR}$	$\overline{T}$	T	Q	$\overline{Q}$
L	X	X	L	H
H	H	X	L[3]	H[3]
H	X	L	L[3]	H[3]
H	L	↑	⊓ [4]	⊔ [4]
H	↓	H	⊓ [4]	⊔ [4]
↑	L	H	⊓	⊔

(1) H = high voltage level, L = low voltage level, X = don't care

(2) L = driving low, H = driving high, ⊓ = driving high for the defined pulse width time, ⊔ = driving low for the defined pulse width time

(3) These outputs are based on the assumption that the indicated steady-state conditions at the inputs have been set up long enough to complete any output pulse.

(4) If an output pulse is triggered while a previous output pulse is still active, the output continues to drive high for one additional pulse width.

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8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

The TPUL2T323 is used to generate a fixed-width pulse from an input trigger event. This device is retriggerable, meaning that input triggers received while the output is active will cause the output pulse to extend and it will not expire until one configured time period after the most recent trigger.

The input trigger event comes from three gated inputs: $\overline{T}$, T, and $\overline{CLR}$. These inputs are combined in a 3-input AND gate, with $\overline{T}$ internally inverted such that the logic follows the boolean equation $Y = !(\overline{T}) \cdot T \cdot \overline{CLR}$. Each input has a Schmitt-trigger architecture, and thus includes hysteresis allowing for slow transitioning or noisy signals. An input signal is detected as a logic high if the signal is larger than V_{T+}, and a low if the input signal is smaller than V_{T-}. Between V_{T+} and V_{T-}, the input signal is detected as the last valid state until one of those values is crossed. An output pulse is triggered on the rising edge of the aforementioned internal Y signal.

The output pulse width is controlled by the selection of external timing components R_{ext} and C_{ext}. Plots are provided in the *Typical Characteristics* section to easily select appropriate component values for a desired pulse width. See the *Features* section for additional information regarding the impact of external components on the timing accuracy of the TPUL2T323.

8.2 Typical Application - Edge Detector

In this application, the TPUL2T323 is used to detect rising or falling edges on an input signal, producing short pulses at the output for each edge detected. The circuit configuration for a rising edge detector is shown in Figure 8-1. For a falling edge detector, connect the input signal to the $\overline{T}$ input instead of the T input, and connect the T input to V_{CC}. Otherwise, the components and configuration are identical.
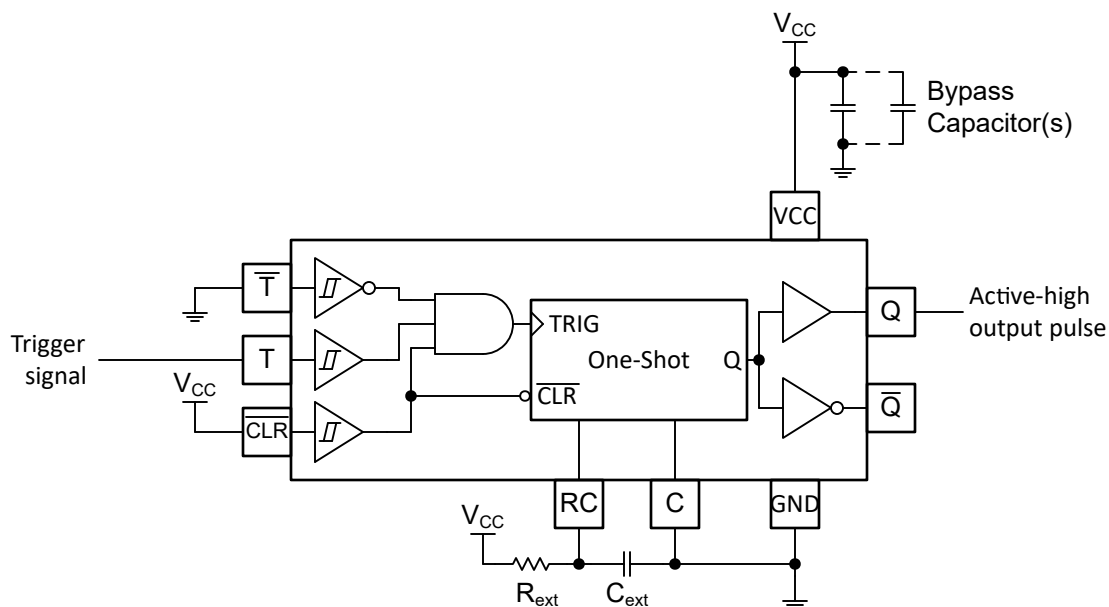

Figure 8-1. Pulse generator schematic using the TPUL2T323

8.2.1 Design Requirements

8.2.1.1 Timing Components

The external timing components directly determine the output pulse width of the TPUL2T323.

The range of supported values for R_{ext} and C_{ext} are provided in the *Recommended Operating Conditions* table. Do not exceed the limits provided in the *Absolute Maximum Ratings* table.

The TPUL2T323 can be used with no external capacitor, which is described as C_{ext} = 0pF. In this condition, the output pulse width is determined by the operating voltage and external timing resistor, R_{ext}, only. The expected variation is provided in the *Switching Characteristics* table for the case of R_{ext} = 1MΩ, C_{ext} = 0pF.

If an external timing capacitor larger than 1µF is used, add an external Schottky diode (D_{ext}) as shown in Figure 8-2 to provide an alternate discharge path for the capacitor during power down.
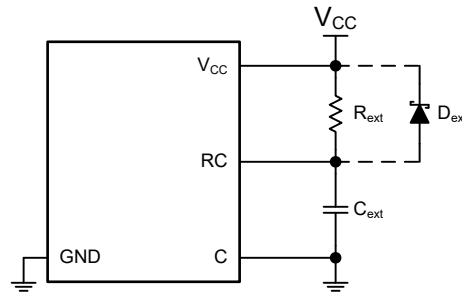

Figure 8-2. External protection diode connection

8.2.1.2 Input Considerations

Input signals must cross to be considered a logic LOW, and to be considered a logic HIGH. Do not exceed the maximum input voltage range found in the *Absolute Maximum Ratings*.

Unused inputs must be terminated to either V_{CC} or ground. The unused inputs can be directly terminated if the input is completely unused, or they can be connected with a pull-up or pull-down resistor if the input will be used sometimes, but not always. A pull-up resistor is used for a default state of HIGH, and a pull-down resistor is used for a default state of LOW. The drive current of the controller, leakage current into the TPUL2T323 (as specified in the *Electrical Characteristics*), and the desired input transition rate limits the resistor size. A 10kΩ resistor value is recommended for most applications.

Refer to the *Feature Description* section for additional information regarding the inputs for this device.

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8.2.1.3 Output Considerations

The positive supply voltage is used to produce the output HIGH-state voltage. Drawing current from the output decreases the output voltage as specified by the V_{OH} specification in the *Electrical Characteristics*. The ground voltage is used to produce the output LOW-state voltage. Sinking current into the output increases the output voltage as specified by the V_{OL} specification in the *Electrical Characteristics*.

Push-pull outputs that could be in opposite states, even for a very short time period, should never be connected directly together to avoid excessive current and damage to the device.

The TPUL2T323 can directly drive a load with a total capacitance less than or equal to 50pF while still meeting all of the data sheet specifications. For larger capacitive loads, add a series resistor to maintain current within the *Absolute Maximum Ratings*.

The TPUL2T323 can drive a load with total resistance described by $R_L \geq V_O / I_O$, with the output voltage and current defined in the *Electrical Characteristics* table with V_{OH} and V_{OL}. When outputting in the HIGH state, the output voltage in the equation is defined as the difference between the measured output voltage and the supply voltage at the V_{CC} pin.

Unused outputs can be left floating. Do not connect outputs directly to V_{CC} or ground.

Refer to the *Feature Description* section for additional information regarding the outputs for this device.

8.2.1.4 Power Considerations

Ensure the desired supply voltage is within the range specified in the *Recommended Operating Conditions*. The supply voltage sets the electrical characteristics of the device as described in the *Electrical Characteristics* section.

The ground must be capable of sinking current equal to the total current to be sunk by all outputs of the TPUL2T323 plus the maximum supply current, I_{CC}, listed in the *Electrical Characteristics*, and any transient current required for switching. The logic device can only sink as much current that can be sunk into its ground connection. Ensure the maximum total current through GND listed in the *Absolute Maximum Ratings* is not exceeded.

Thermal increase can be calculated using the information provided in *Thermal Characteristics of Standard Linear and Logic (SLL) Packages and Devices*.

> **CAUTION**
> The maximum junction temperature, $T_{J(max)}$ listed in the *Absolute Maximum Ratings*, is an additional limitation to prevent damage to the device. Do not violate any values listed in the *Absolute Maximum Ratings*. These limits are provided to prevent damage to the device.

Product Folder Links: *TPUL2T323*

8.2.2 Detailed Design Procedure

Texas Instruments provides an Excel-based calculator for getting the best results when using the TPUL2T323. This calculator can be found through the device's product folder, located in the *Design and development* section. The steps below are used for manually calculating the required timing component values using the information available in this document.

1. Select the desired output pulse width (t_{wo}), and calculate $t_{wo1} = t_{wo} / 1024$.
2. Solve: $C_{ext1} = t_{wo1}/50000$.
3. Select the nearest decade capacitor value to C_{ext1} from the following and use for C_{ext}. { 100pF, 1nF, 10nF, 100nF, 1µF, 10µF }
4. Solve: $R_{ext1} = t_{wo1}/C_{ext}$.
5. Using R_{ext1} from step 4 and C_{ext} from step 3, find the closest K factor using the appropriate plot from the *Typical Characteristics* section.
6. Solve: $R_{ext} = t_{wo1}/(K × C_{ext})$
7. Connect the selected timing resistor, R_{ext}, from RC to V_{CC}.
8. Connect the selected timing capacitor, C_{ext}, from RC (positive) to C (negative). The C pin can additionally be connected to ground, however it is not required for normal operation.
9. Add a 0.1µF bypass capacitor from V_{CC} to GND. The capacitor needs to be placed physically close to the device and electrically close to both the V_{CC} and GND pins. An example layout is shown in the *Layout* section.
10. Ensure the capacitive load at the output is ≤ 50pF. This is not a hard limit, however, it will optimize performance and prevent reliability issues. This can be accomplished by providing short, appropriately sized traces from the TPUL2T323 to any receiving devices.
11. Ensure the resistive load at the output is larger than (V_{CC} / $I_{O(max)}$)Ω. Doing this will prevent the maximum output current from the *Absolute Maximum Ratings* from being violated. Most CMOS inputs have a resistive load measured in MΩ; much larger than the minimum calculated previously.
12. Thermal issues are rarely a concern for TPUL family devices, however, the power consumption and thermal increase can be calculated using the steps provided in the application report, *CMOS Power Consumption and Cpd Calculation*.
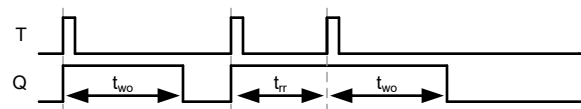
8.2.3 Application Curves

Figure 8-3. Output Pulse Timing Diagram

ADVANCE INFORMATION

8.3 Typical Application - Delayed Pulse Generator

In this application, the TPUL2T323 is used to produce a delayed output pulse from a rising edge input trigger. The circuit configuration is shown in Figure 8-4.
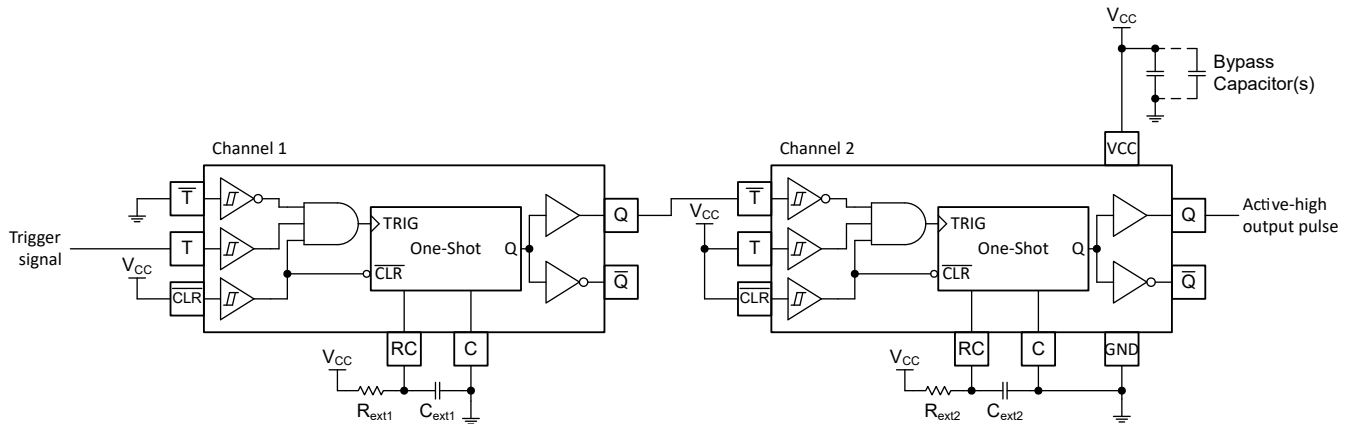

Figure 8-4. Delayed pulse generation schematic using the TPUL2T323
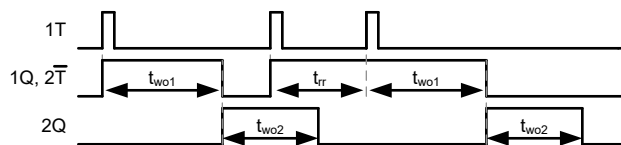
8.3.1 Application Curves

Figure 8-5. Output Pulse Timing Diagram

8.4 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating listed in the *Recommended Operating Conditions*.

During startup, the power supply should ramp within the provided power-up ramp rate range in the *Recommended Operating Conditions* table.

Each V_{CC} terminal must have a good bypass capacitor to prevent power disturbance. For normal operation of the TPUL2T323, a 0.1µF bypass capacitor is recommended. To reject different frequencies of noise, use multiple bypass capacitors in parallel. Capacitors with values of 0.1µF and 1µF are commonly used in parallel.

ADVANCE INFORMATION

8.5 Layout

8.5.1 Layout Guidelines

- Timing component placement
  - Place near the device
  - Provide an electrically short path to the device terminal connections
- Bypass capacitor placement
  - Place near the positive supply terminal of the device
  - Provide an electrically short ground return path
  - Use wide traces to minimize impedance
  - Keep the device, capacitors, and traces on the same side of the board whenever possible
- Signal trace geometry
  - 8mil to 12mil trace width
  - Lengths less than 12cm to minimize transmission line effects
  - Avoid 90° corners for signal traces
  - Use an unbroken ground plane below signal traces
  - Flood fill areas around signal traces with ground
  - For traces longer than 12cm
    - Use impedance controlled traces
    - Source-terminate using a series damping resistor near the output
    - Avoid branches; buffer signals that must branch separately

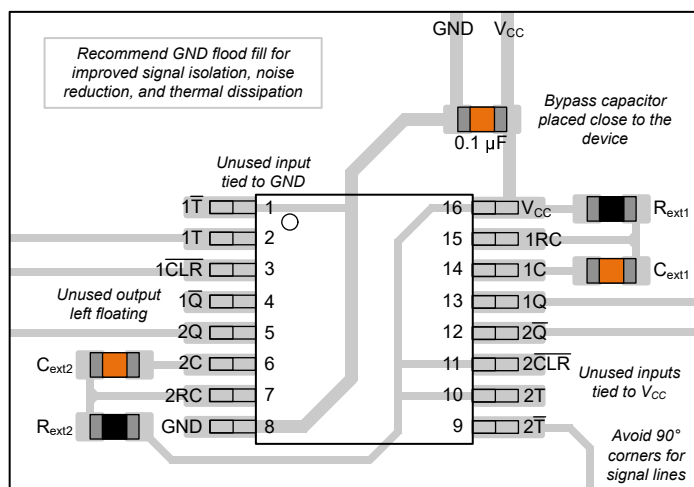### 8.5.2 Layout Example

Figure 8-6. Layout Example for TPUL2T323 in the PW (TSSOP) package

9 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

9.1 Documentation Support

9.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, *CMOS Power Consumption and C_{pd} Calculation* application report
- Texas Instruments, *Designing With Logic* application report
- Texas Instruments, *Thermal Characteristics of Standard Linear and Logic (SLL) Packages and Devices* application report

9.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

9.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

9.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

9.5 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.6 Glossary

TI Glossary   This glossary lists and explains terms, acronyms, and definitions.

10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

DATE	REVISION	NOTES
April 2025	*	Advance Information Release

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.
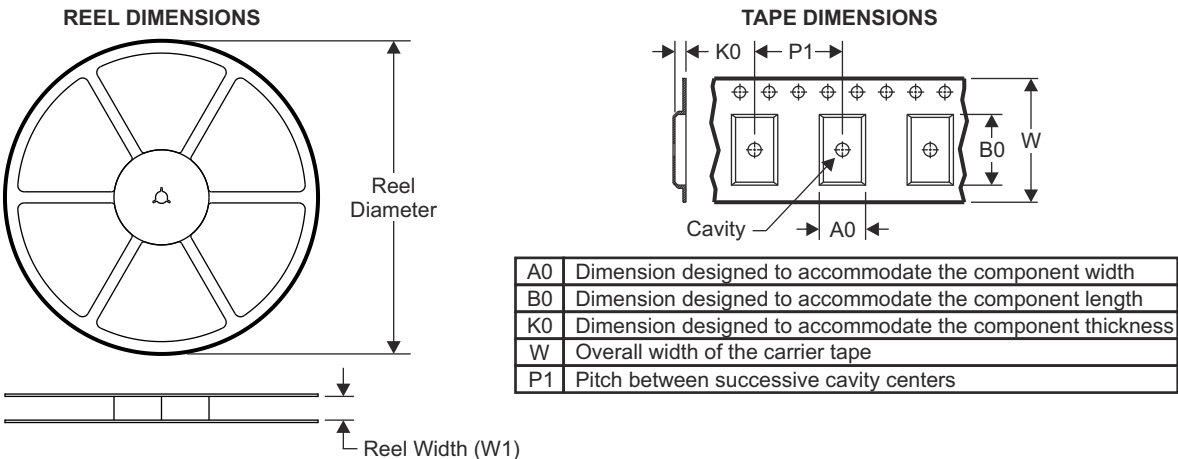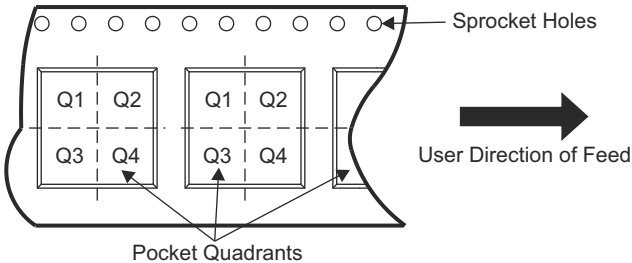
11.1 Packaging Option Addendum

Packaging Information

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish(4)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking(5) (6)
PTPUL2T323PWR	PREVIEW	PW	TSSOP	16	3000	RoHS & Green		LEVEL1-260CG	-40 to 125	P1

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PRE_PROD Unannounced device, not in production, not available for mass market, nor on the web, samples not available.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The Pb-Free/Green conversion plan has not been defined.
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.
Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

(5) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device

(6) Multiple Device markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

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11.2 Tape and Reel Information

ADVANCE INFORMATION

REEL DIMENSIONS

Reel Diameter

Reel Width (W1)

TAPE DIMENSIONS

Cavity

A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

Sprocket Holes

User Direction of Feed

Pocket Quadrants

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
PTPUL2T323PWR	PW	TSSOP	16	3000	330	12.4	6.90	5.60	1.60	8	9.10	Q1

Product Folder Links: *TPUL2T323*

TAPE AND REEL BOX DIMENSIONS
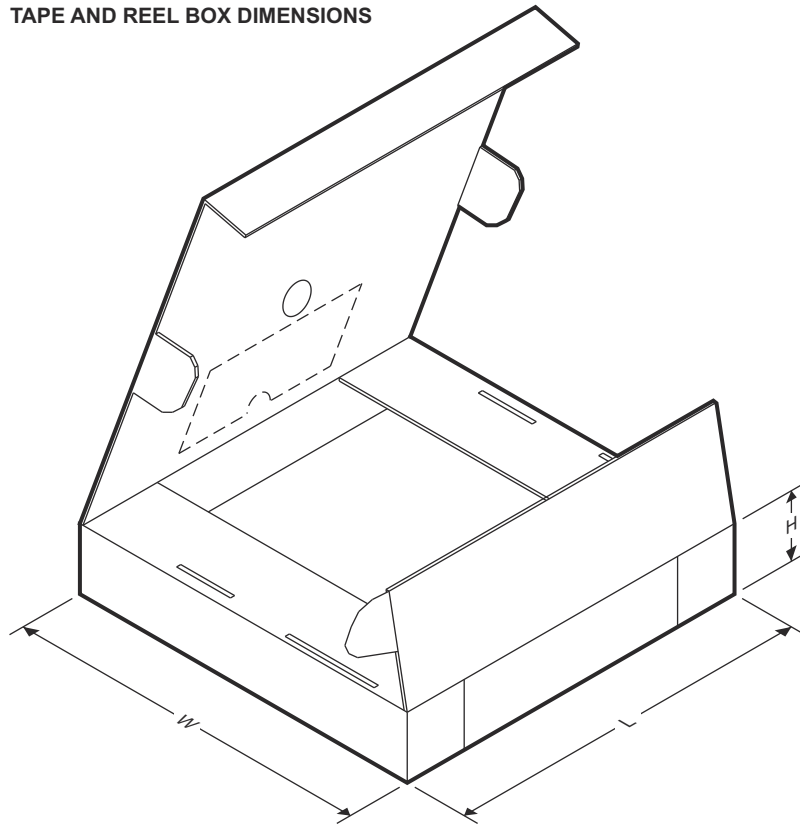
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
PTPUL2T323PWR	PW	TSSOP	16	3000	353	353	32

ADVANCE INFORMATION

11.3 Mechanical Data
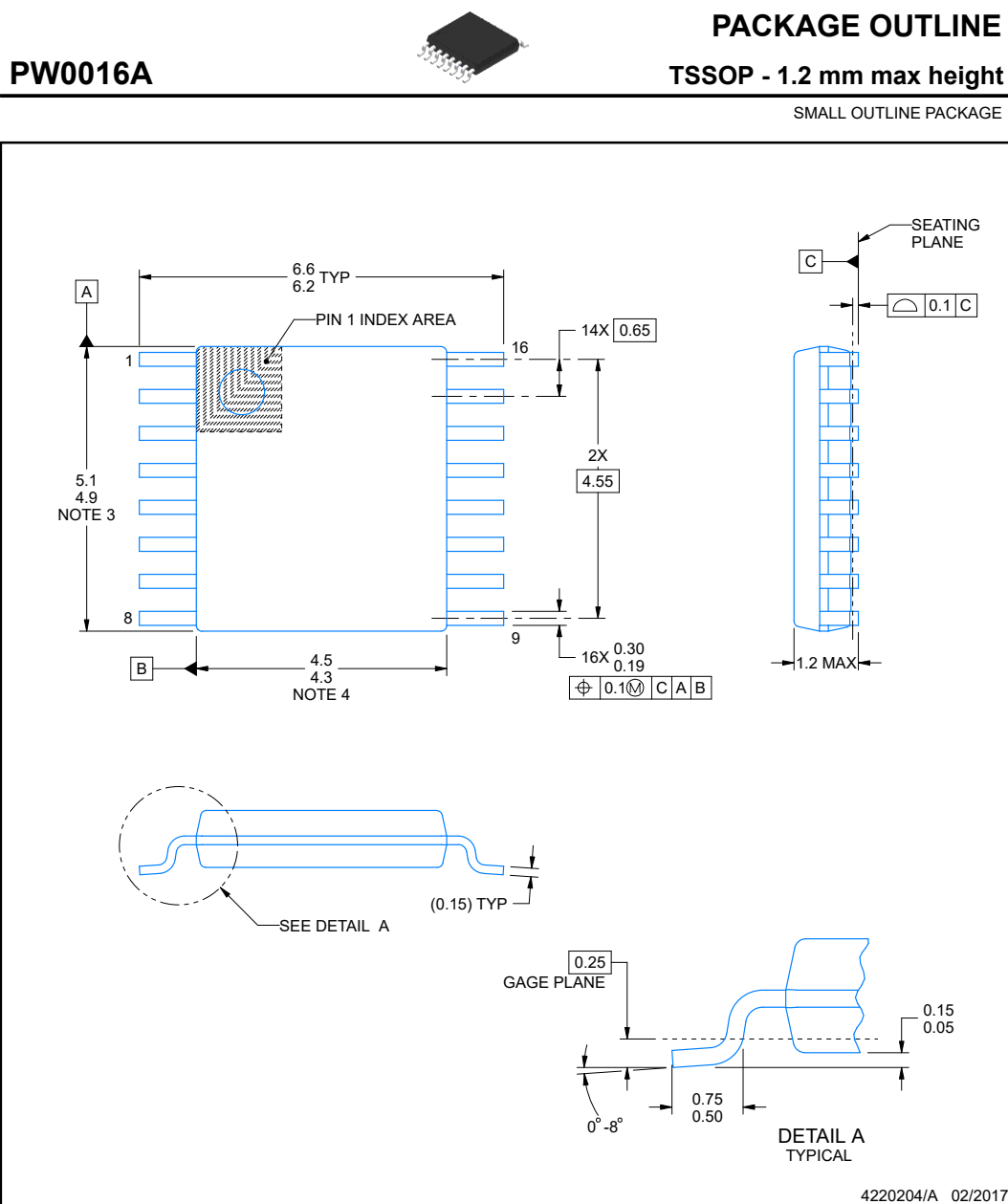
PW0016A

PACKAGE OUTLINE

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE

4220204/A   02/2017

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

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EXAMPLE BOARD LAYOUT

PW0016A

TSSOP - 1.2 mm max height
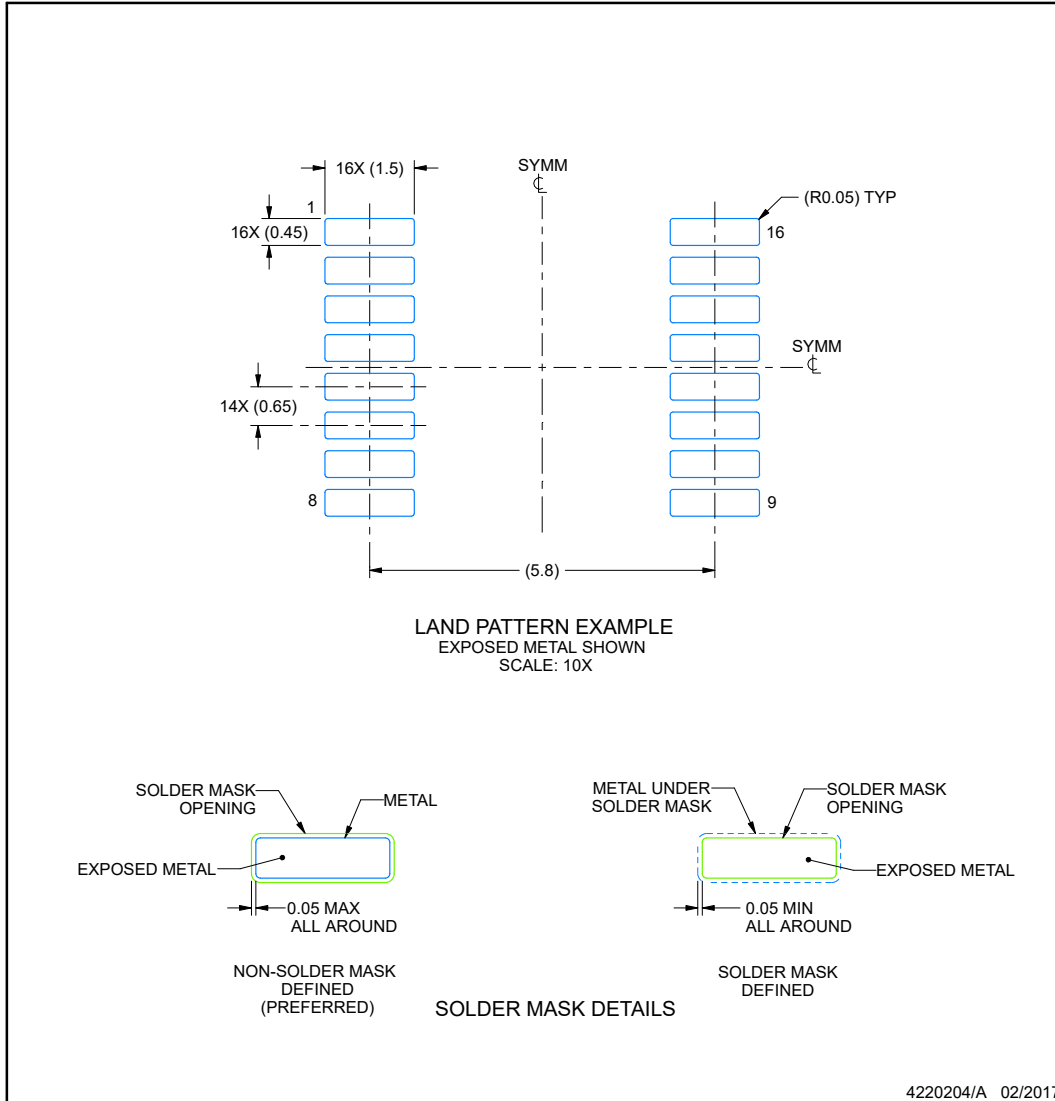
SMALL OUTLINE PACKAGE

16X (1.5)

SYMM

1

16X (0.45)

(R0.05) TYP

16

SYMM

14X (0.65)

8

9

(5.8)

LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X

SOLDER MASK
OPENING

METAL

EXPOSED METAL

0.05 MAX
ALL AROUND

NON-SOLDER MASK
DEFINED
(PREFERRED)

METAL UNDER
SOLDER MASK

SOLDER MASK
OPENING

EXPOSED METAL

0.05 MIN
ALL AROUND

SOLDER MASK
DEFINED

SOLDER MASK DETAILS

4220204/A 02/2017

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

ADVANCE INFORMATION

EXAMPLE STENCIL DESIGN

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE

SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220204/A 02/2017

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

ADVANCE INFORMATION

TEXAS INSTRUMENTS
www.ti.com

Product Folder Links: *TPUL2T323*

PACKAGE OPTION ADDENDUM

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
PTPUL2T323PWR	Active	Preproduction	TSSOP (PW) | 16	3000 | LARGE T&R	-	Call TI	Call TI	-40 to 125	
PTPUL2T323PWR.A	Active	Preproduction	TSSOP (PW) | 16	3000 | LARGE T&R	-	Call TI	Call TI	-40 to 125	

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

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6.6
6.2 TYP

A

PIN 1 INDEX AREA

14X 0.65

16

1

5.1
4.9
NOTE 3

2X

4.55

8

9

B

4.5
4.3
NOTE 4

16X 0.30
0.17

⊕ 0.1Ⓜ C A B

SEATING PLANE

C

◯ 0.1 C

4X (0°-12°)

1.2 MAX

SEE DETAIL A

(0.15) TYP

0.25
GAGE PLANE

0.15
0.05

0.75
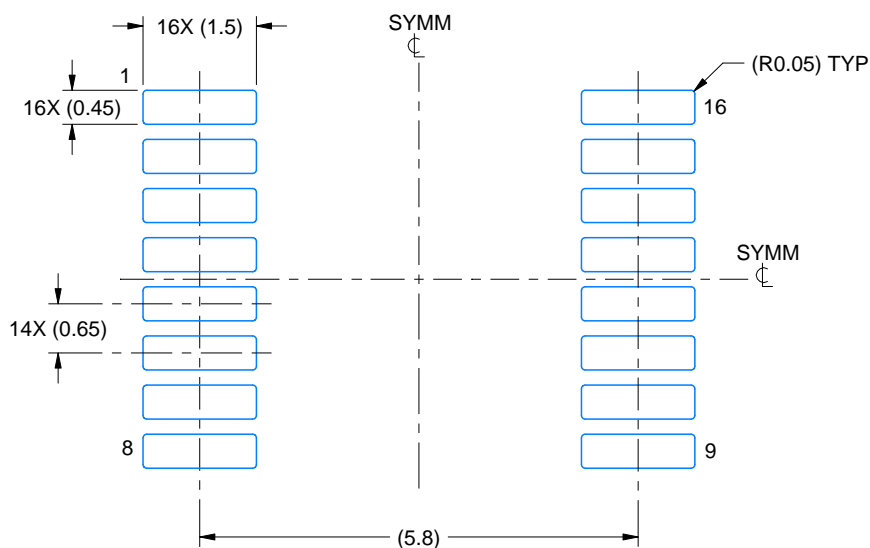0.50

0°-8°

DETAIL A
TYPICAL

4220204/B   12/2023

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

PW0016A

16X (1.5)

SYMM ₵

(R0.05) TYP

1

16X (0.45)

16

SYMM ₵

14X (0.65)

8

9

(5.8)

LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X

SOLDER MASK
OPENING

METAL

EXPOSED METAL

0.05 MAX
ALL AROUND

NON-SOLDER MASK
DEFINED
(PREFERRED)

METAL UNDER
SOLDER MASK

SOLDER MASK
OPENING

EXPOSED METAL

0.05 MIN
ALL AROUND

SOLDER MASK
DEFINED

SOLDER MASK DETAILS

4220204/B   12/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220204/B   12/2023

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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